

# 1Mx18, 512Kx36 18Mb DDR-II (Burst 4) CIO SYNCHRONOUS SRAM

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## FEATURES

- 512Kx36 and 1Mx18 configuration available.
- On-chip delay-locked loop (DLL) for wide data valid window.
- Common I/O read and write ports.
- Synchronous pipeline read with late write operation.
- Double Data Rate (DDR) interface for read and write input ports.
- Fixed 4-bit burst for read and write operations.
- Clock stop support.
- Two input clocks (K and K#) for address and control registering at rising edges only.
- Two input clocks (C and C#) for data output control.
- Two echo clocks (CQ and CQ#) that are delivered simultaneously with data.
- +1.8V core power supply and 1.5V to 1.8V VDDQ, used with 0.75V to 0.9V VREF.
- HSTL input and output interface.
- Registered addresses, write and read controls, byte writes, data in, and data outputs.
- Full data coherency.
- Boundary scan using limited set of JTAG 1149.1 functions.
- Byte write capability.
- Fine ball grid array (FBGA) package:
  - 13mmx15mm and 15mmx17mm body size
  - 165-ball (11 x 15) array
- Programmable impedance output drivers via 5x user-supplied precision resistor.

## DESCRIPTION

The 18Mb IS61DDB451236A and IS61DDB41M18A are synchronous, high-performance CMOS static random access memory (SRAM) devices. These SRAMs have a common I/O bus. The rising edge of K clock initiates the read/write operation, and all internal operations are self-timed. Refer to the *Timing Reference Diagram for Truth Table* for a description of the basic operations of these DDR-II (Burst of 4) CIO SRAMs.

Read and write addresses are registered on alternating rising edges of the K clock. Reads and writes are performed in double data rate.

The following are registered internally on the rising edge of the K clock:

- Read/write address
- Read enable
- Write enable
- Byte writes for burst addresses first and third
- Data-in for burst addresses first and third

The following are registered on the rising edge of the K# clock:

- Byte writes for burst addresses second and fourth
- Data-in for burst addresses second and fourth

Byte writes can change with the corresponding data-in to enable or disable writes on a per-byte basis. An internal write buffer enables the data-ins to be registered one cycle after the write address. The first data-in burst is clocked one cycle later than the write command signal, and the second burst is timed to the following rising edge of the K# clock. Two full clock cycles are required to complete a write operation.

During the burst read operation, the data-outs from the first and third bursts are updated from output registers of the second and third rising edges of the C# clock (starting on and half cycles later after read command). The data-outs from the second and fourth bursts are updated with the third and fourth rising edges of the C clock. The K and K# clocks are used to time the data-outs whenever the C and C# clocks are tied high. Two full clock cycles are required to complete a read operation.

The device is operated with a single +1.8V power supply and is compatible with HSTL I/O interfaces.

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## Package Ballout and description

### x36 FBGA Ball Configuration (Top View)

|   | 1                  | 2                  | 3                  | 4                | 5                 | 6               | 7                 | 8                | 9                | 10                 | 11   |
|---|--------------------|--------------------|--------------------|------------------|-------------------|-----------------|-------------------|------------------|------------------|--------------------|------|
| A | CQ#                | NC/SA <sup>1</sup> | NC/SA <sup>1</sup> | R/W#             | BW <sub>2</sub> # | K#              | BW <sub>1</sub> # | LD#              | SA               | NC/SA <sup>1</sup> | CQ   |
| B | NC                 | DQ27               | DQ18               | SA               | BW <sub>3</sub> # | K               | BW <sub>0</sub> # | SA               | NC               | NC                 | DQ8  |
| C | NC                 | NC                 | DQ28               | V <sub>SS</sub>  | SA                | SA <sub>0</sub> | SA <sub>1</sub>   | V <sub>SS</sub>  | NC               | DQ17               | DQ7  |
| D | NC                 | DQ29               | DQ19               | V <sub>SS</sub>  | V <sub>SS</sub>   | V <sub>SS</sub> | V <sub>SS</sub>   | V <sub>SS</sub>  | NC               | NC                 | DQ16 |
| E | NC                 | NC                 | DQ20               | V <sub>DDQ</sub> | V <sub>SS</sub>   | V <sub>SS</sub> | V <sub>SS</sub>   | V <sub>DDQ</sub> | NC               | DQ15               | DQ6  |
| F | NC                 | DQ30               | DQ21               | V <sub>DDQ</sub> | V <sub>DD</sub>   | V <sub>SS</sub> | V <sub>DD</sub>   | V <sub>DDQ</sub> | NC               | NC                 | DQ5  |
| G | NC                 | DQ31               | DQ22               | V <sub>DDQ</sub> | V <sub>DD</sub>   | V <sub>SS</sub> | V <sub>DD</sub>   | V <sub>DDQ</sub> | NC               | NC                 | DQ14 |
| H | D <sub>off</sub> # | V <sub>REF</sub>   | V <sub>DDQ</sub>   | V <sub>DDQ</sub> | V <sub>DD</sub>   | V <sub>SS</sub> | V <sub>DD</sub>   | V <sub>DDQ</sub> | V <sub>DDQ</sub> | V <sub>REF</sub>   | ZQ   |
| J | NC                 | NC                 | DQ32               | V <sub>DDQ</sub> | V <sub>DD</sub>   | V <sub>SS</sub> | V <sub>DD</sub>   | V <sub>DDQ</sub> | NC               | DQ13               | DQ4  |
| K | NC                 | NC                 | DQ23               | V <sub>DDQ</sub> | V <sub>DD</sub>   | V <sub>SS</sub> | V <sub>DD</sub>   | V <sub>DDQ</sub> | NC               | DQ12               | DQ3  |
| L | NC                 | DQ33               | DQ24               | V <sub>DDQ</sub> | V <sub>SS</sub>   | V <sub>SS</sub> | V <sub>SS</sub>   | V <sub>DDQ</sub> | NC               | NC                 | DQ2  |
| M | NC                 | NC                 | DQ34               | V <sub>SS</sub>  | V <sub>SS</sub>   | V <sub>SS</sub> | V <sub>SS</sub>   | V <sub>SS</sub>  | NC               | DQ11               | DQ1  |
| N | NC                 | DQ35               | DQ25               | V <sub>SS</sub>  | SA                | SA              | SA                | V <sub>SS</sub>  | NC               | NC                 | DQ10 |
| P | NC                 | NC                 | DQ26               | SA               | SA                | C               | SA                | SA               | NC               | DQ9                | DQ0  |
| R | TDO                | TCK                | SA                 | SA               | SA                | C#              | SA                | SA               | SA               | TMS                | TDI  |

Notes:

- The following balls are reserved for higher densities: 3A for 36Mb, 10A for 72Mb and 2A for 144Mb.

### x18 FBGA Ball Configuration (Top View)

|   | 1                  | 2                  | 3                | 4                | 5                  | 6               | 7                  | 8                | 9                | 10                 | 11  |
|---|--------------------|--------------------|------------------|------------------|--------------------|-----------------|--------------------|------------------|------------------|--------------------|-----|
| A | CQ#                | NC/SA <sup>1</sup> | SA               | R/W#             | BW <sub>1</sub> #  | K#              | NC/SA <sup>1</sup> | LD#              | SA               | NC/SA <sup>1</sup> | CQ  |
| B | NC                 | DQ9                | NC               | SA               | NC/SA <sup>1</sup> | K               | BW <sub>0</sub> #  | SA               | NC               | NC                 | DQ8 |
| C | NC                 | NC                 | NC               | V <sub>SS</sub>  | SA                 | SA <sub>0</sub> | SA <sub>1</sub>    | V <sub>SS</sub>  | NC               | DQ7                | NC  |
| D | NC                 | NC                 | DQ10             | V <sub>SS</sub>  | V <sub>SS</sub>    | V <sub>SS</sub> | V <sub>SS</sub>    | V <sub>SS</sub>  | NC               | NC                 | NC  |
| E | NC                 | NC                 | DQ11             | V <sub>DDQ</sub> | V <sub>SS</sub>    | V <sub>SS</sub> | V <sub>SS</sub>    | V <sub>DDQ</sub> | NC               | NC                 | DQ6 |
| F | NC                 | DQ12               | NC               | V <sub>DDQ</sub> | V <sub>DD</sub>    | V <sub>SS</sub> | V <sub>DD</sub>    | V <sub>DDQ</sub> | NC               | NC                 | DQ5 |
| G | NC                 | NC                 | DQ13             | V <sub>DDQ</sub> | V <sub>DD</sub>    | V <sub>SS</sub> | V <sub>DD</sub>    | V <sub>DDQ</sub> | NC               | NC                 | NC  |
| H | D <sub>off</sub> # | V <sub>REF</sub>   | V <sub>DDQ</sub> | V <sub>DDQ</sub> | V <sub>DD</sub>    | V <sub>SS</sub> | V <sub>DD</sub>    | V <sub>DDQ</sub> | V <sub>DDQ</sub> | V <sub>REF</sub>   | ZQ  |
| J | NC                 | NC                 | NC               | V <sub>DDQ</sub> | V <sub>DD</sub>    | V <sub>SS</sub> | V <sub>DD</sub>    | V <sub>DDQ</sub> | NC               | DQ4                | NC  |
| K | NC                 | NC                 | DQ14             | V <sub>DDQ</sub> | V <sub>DD</sub>    | V <sub>SS</sub> | V <sub>DD</sub>    | V <sub>DDQ</sub> | NC               | NC                 | DQ3 |
| L | NC                 | DQ15               | NC               | V <sub>DDQ</sub> | V <sub>SS</sub>    | V <sub>SS</sub> | V <sub>SS</sub>    | V <sub>DDQ</sub> | NC               | NC                 | DQ2 |
| M | NC                 | NC                 | NC               | V <sub>SS</sub>  | V <sub>SS</sub>    | V <sub>SS</sub> | V <sub>SS</sub>    | V <sub>SS</sub>  | NC               | DQ1                | NC  |
| N | NC                 | NC                 | DQ16             | V <sub>SS</sub>  | SA                 | SA              | SA                 | V <sub>SS</sub>  | NC               | NC                 | NC  |
| P | NC                 | NC                 | DQ17             | SA               | SA                 | C               | SA                 | SA               | NC               | NC                 | DQ0 |
| R | TDO                | TCK                | SA               | SA               | SA                 | C#              | SA                 | SA               | SA               | TMS                | TDI |

Notes:

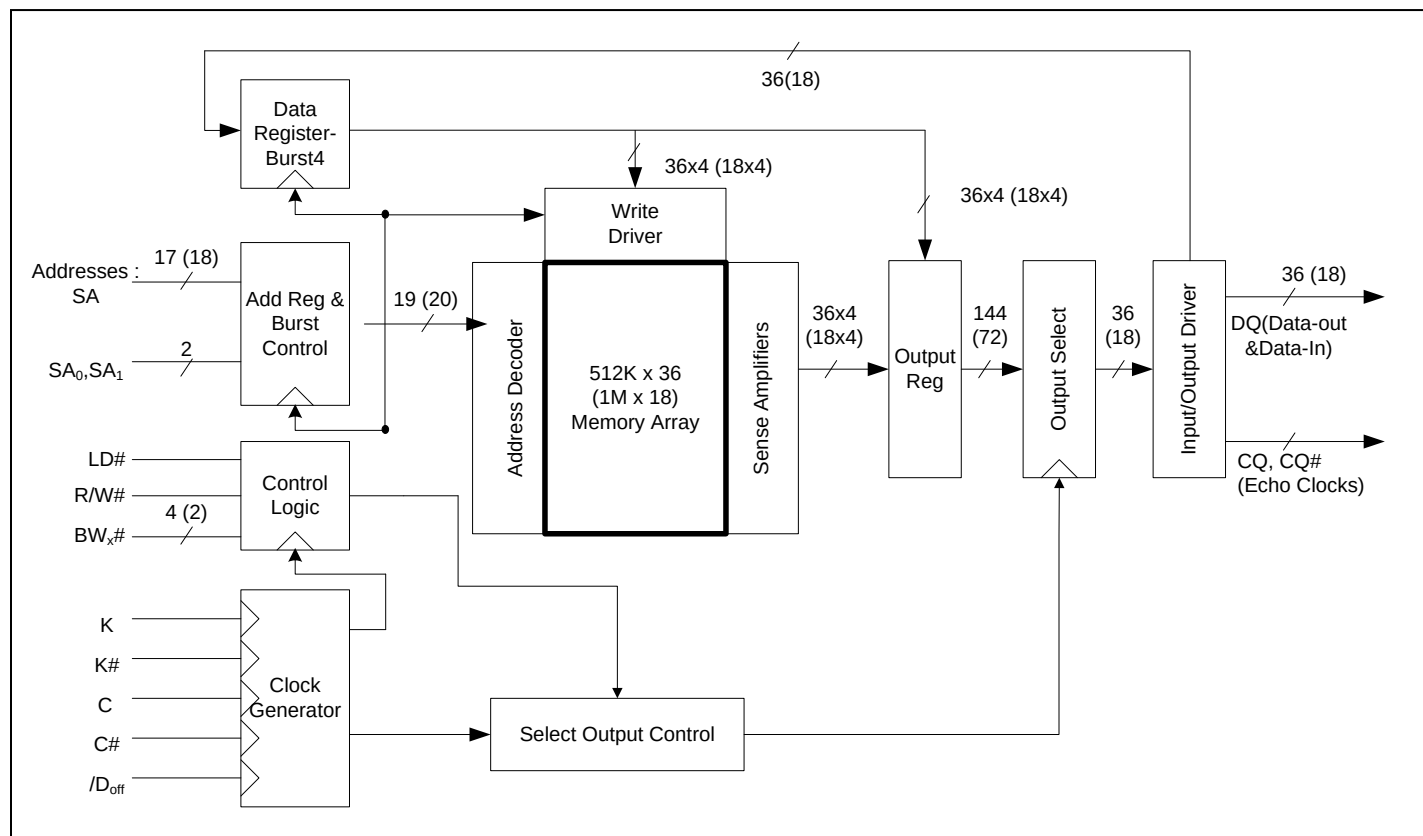
- The following balls are reserved for higher densities: 10A for 36Mb, 2A for 72Mb and 7A for 144Mb and 5B for 288Mb.

## Ball Description

| Symbol            | Type            | Description                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                 |
|-------------------|-----------------|-------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| K, K#             | Input           | Input clock: This input clock pair registers address and control inputs on the rising edge of K, and registers data on the rising edge of K and the rising edge of K#. K# is ideally 180 degrees out of phase with K. All synchronous inputs must meet setup and hold times around the clock rising edges. These balls cannot remain VREF level.                                                                                                                                                                                                                                                            |
| C, C#             | Input           | Input clock for output data. C and C# are used to clock out the READ data. They can be used together to deskew the flight times of various devices on the board back to the controller. See application example for further details.                                                                                                                                                                                                                                                                                                                                                                        |
| CQ, CQ#           | Output          | Synchronous echo clock outputs: The edges of these outputs are tightly matched to the synchronous data outputs and can be used as a data valid indication. These signals are free running clocks and do not stop when Q tri-states.                                                                                                                                                                                                                                                                                                                                                                         |
| Doff#             | Input           | DLL disable and reset input : when low, this input causes the DLL to be bypassed and reset the previous DLL information. When high, DLL will start operating and lock the frequency after tCK lock time. The device behaves in one read latency mode when the DLL is turned off. In this mode, the device can be operated at a frequency of up to 167 MHz.                                                                                                                                                                                                                                                  |
| SA                | Input           | Synchronous address inputs: These inputs are registered and must meet the setup and hold times around the rising edge of K. These inputs are ignored when device is deselected.                                                                                                                                                                                                                                                                                                                                                                                                                             |
| DQ0 - DQn         | Bidir           | Data input and output signals. Input data must meet setup and hold times around the rising edges of K and K# during WRITE operations. These pins drive out the requested data when the read operation is active. Valid output data is synchronized to the respective C and C#, or to the respective K and K# if C and /C are tied to high. When read access is deselected, DQ0 - DQn are automatically tri-stated.<br>See BALL CONFIGURATION figures for ball site location of individual signals.<br>The x18 device uses DQ0~DQ17. DQ18~DQ35 should be treated as NC pin.<br>The x36 device uses DQ0~DQ35. |
| R/W#              | Input           | Synchronous Read or Write input. When LD# is low, this input designates the access type (read when it is High, write when it is Low) for loaded address. R/W# must meet the setup and hold times around edge of K.                                                                                                                                                                                                                                                                                                                                                                                          |
| LD#               | Input           | Synchronous load. This input is brought Low when a bus cycle sequence is defined. This definition includes address and read/write direction.                                                                                                                                                                                                                                                                                                                                                                                                                                                                |
| BW <sub>x</sub> # | Input           | Synchronous byte writes: When low, these inputs cause their respective byte to be registered and written during WRITE cycles. These signals are sampled on the same edge as the corresponding data and must meet setup and hold times around the rising edges of K and #K for each of the two rising edges comprising the WRITE cycle. See Write Truth Table for signal to data relationship.                                                                                                                                                                                                               |
| V <sub>REF</sub>  | Input reference | HSTL input reference voltage: Nominally VDDQ/2, but may be adjusted to improve system noise margin. Provides a reference voltage for the HSTL input buffers.                                                                                                                                                                                                                                                                                                                                                                                                                                                |
| V <sub>DD</sub>   | Power           | Power supply: 1.8 V nominal. See DC Characteristics and Operating Conditions for range.                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                     |
| V <sub>DDQ</sub>  | Power           | Power supply: Isolated output buffer supply. Nominally 1.5 V. See DC Characteristics and Operating Conditions for range.                                                                                                                                                                                                                                                                                                                                                                                                                                                                                    |
| V <sub>SS</sub>   | Ground          | Ground of the device                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                        |
| ZQ                | Input           | Output impedance matching input: This input is used to tune the device outputs to the system data bus impedance. DQ and CQ output impedance are set to 0.2xRQ, where RQ is a resistor from this ball to ground. This ball can be connected directly to VDDQ, which enables the minimum impedance mode. This ball cannot be connected directly to VSS or left unconnected.                                                                                                                                                                                                                                   |
| TMS, TDI, TCK     | Input           | IEEE1149.1 input pins for JTAG.                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                             |
| TDO               | Output          | IEEE1149.1 output pins for JTAG.                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                            |
| NC                | N/A             | No connect: These signals should be left floating or connected to ground to improve package heat dissipation.                                                                                                                                                                                                                                                                                                                                                                                                                                                                                               |

## SRAM Features description

### Block Diagram



Note: Numerical values in parentheses refer to the x18 device configuration.

### Read Operations

The SRAM operates continuously in a burst-of-four mode. Read cycles are started by registering R/W# in active high state at the rising edge of the K clock. R/W# can be activated every other cycle because two full cycles are required to complete the burst-of-four read in DDR mode. A second set of clocks, C and C#, are used to control the timing to the outputs. A set of free-running echo clocks, CQ and CQ#, are produced internally with timings identical to the data-outs. The echo clocks can be used as data capture clocks by the receiver device.

When the C and C# clocks are connected high, the K and K# clocks assume the function of those clocks. In this case, the data corresponding to the first address is clocked one and half cycles later by the rising edge of the K# clock. The data corresponding to the second burst is clocked two cycles later by the following rising edge of the K clock. The third data-out is clocked by the subsequent rising edge of the K# clock, and the fourth data-out is clocked by the subsequent rising edge of the K clock.

Whenever LD# is low, a new address is registered at the rising edge of the K clock. A NOP operation (LD# is high) does not terminate the previous read. The output drivers disable automatically to a high state.

## **Write Operations**

Write operations can also be initiated at every other rising edge of the K clock whenever R/W# is low. The write address is also registered at that time. When the address needs to change, LD# needs to be low simultaneously to be registered by the rising edge of K. Again, the write always occurs in bursts of four.

The write data is provided in a 'late write' mode; that is, the data-in corresponding to the first address of the burst, is presented one cycle later or at the rising edge of the following K clock. The data-in corresponding to the second write burst address follows next, registered by the rising edge of K#. The third data-out is clocked by the subsequent rising edge of the K clock, and the fourth data-out is clocked by the subsequent rising edge of the K# clock.

The data-in provided for writing is initially kept in write buffers. The information on these buffers is written into the array on the third write cycle. A read cycle to the last two write address produces data from the write buffers. The SRAM maintains data coherency.

During a write, the byte writes independently control which byte of any of the four burst addresses is written (see *X18/X36 Write Truth Tables and Timing Reference Diagram for Truth Table*).

Whenever a write is disabled (R/W# is high at the rising edge of K), data is not written into the memory.

## **RQ Programmable Impedance**

An external resistor, RQ, must be connected between the ZQ pin on the SRAM and Vss to enable the SRAM to adjust its output driver impedance. The value of RQ must be 5x the value of the intended line impedance driven by the SRAM. For example, an RQ of 250Ω results in a driver impedance of 50Ω. The allowable range of RQ to guarantee impedance matching is between 175Ω and 350Ω at  $V_{DDQ}=1.5V$ . The RQ resistor should be placed less than two inches away from the ZQ ball on the SRAM module. The capacitance of the loaded ZQ trace must be less than 7.5pF.

The ZQ pin can also be directly connected to  $V_{DDQ}$  to obtain a minimum impedance setting. ZQ should not be connected to  $V_{SS}$ .

## **Programmable Impedance and Power-Up Requirements**

Periodic readjustment of the output driver impedance is necessary as the impedance is greatly affected by drifts in supply voltage and temperature. During power-up, the driver impedance is in the middle of allowable impedances values. The final impedance value is achieved within 1024clock cycles.

## **Clock Consideration**

This device uses an internal DLL for maximum output data valid window. It can be placed in a stopped-clock mode to minimize power and requires only 1024 cycles to restart. No clocks can be issued until VDD reaches its allowable operating range.

## **Single Clock Mode**

This device can be also operated in single-clock mode. In this case, C and C# are both connected high at power-up and must never change. Under this condition, K and K# control the output timings. Either clock pair must have both polarities switching and must never connect to VREF, as they are not differential clocks.

## **Delay Locked Loop (DLL)**

Delay Lock Loop (DLL) is a new system to align the output data coincident with clock rising or falling edge to enhance the output valid timing characteristics. It is locked to the clock frequency and is constantly adjusted to match the clock frequency. Therefore device can have stable output over the temperature and voltage variation.

DLL has a limitation of locking range and jitter adjustment which are specified as tKHKH and tKCvar respectively in the AC timing characteristics. In order to turn this feature off, applying logic low to the Doff# pin will bypass this. In the DLL off mode, the device behaves with one cycle latency and a longer access time which is known in DDR-I or legacy QUAD mode.

The DLL can also be reset without power down by toggling Doff# pin low to high or stopping the input clocks K and K# for a minimum of 30ns.(K and K# must be stayed either at higher than VIH or lower than VIL level. Remaining Vref is not permitted.) DLL reset must be issued when power up or when clock frequency changes abruptly. After DLL being reset, it gets locked after 2048 cycles of stable clock.

## Power-Up and Power-Down Sequences

The recommendation of voltage apply sequence is :  $V_{DD} \rightarrow V_{DDQ}^{1)} \rightarrow V_{REF}^{2)} \rightarrow V_{IN}$

Notes:

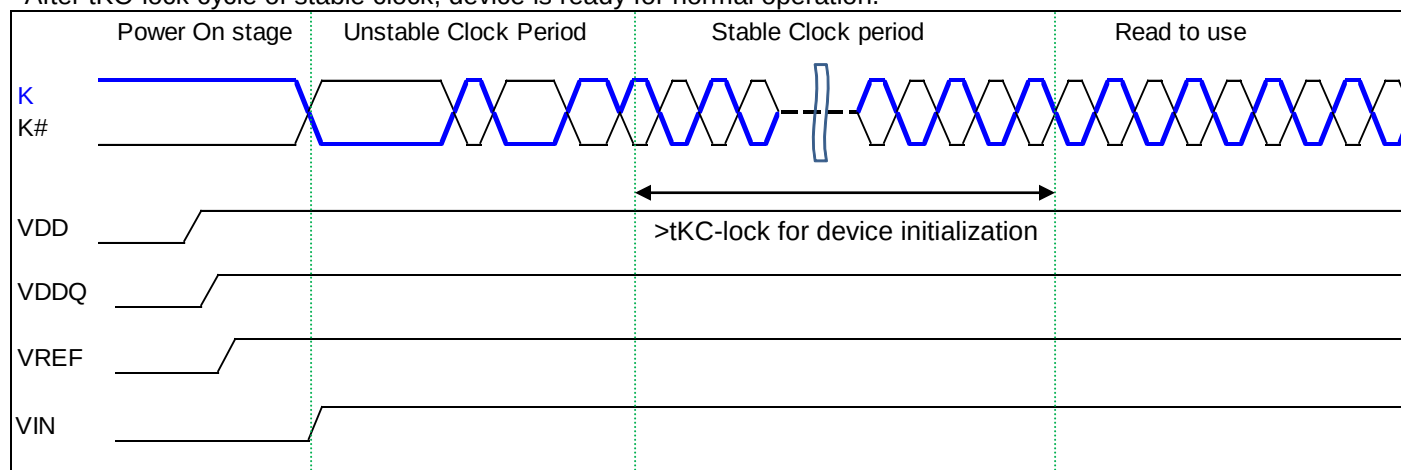
$V_{DDQ}$  can be applied concurrently with  $V_{DD}$ .

$V_{REF}$  can be applied concurrently with  $V_{DDQ}$ .

After power and clock signals are stabilized, device can be ready for normal operation after t<sub>KC-Lock</sub> cycles. In t<sub>KC-Lock</sub> cycle period, device initializes internal logics and locks DLL. Depending on /Doff status, locking DLL will be skipped. The following timing pictures are possible examples of power up sequence.

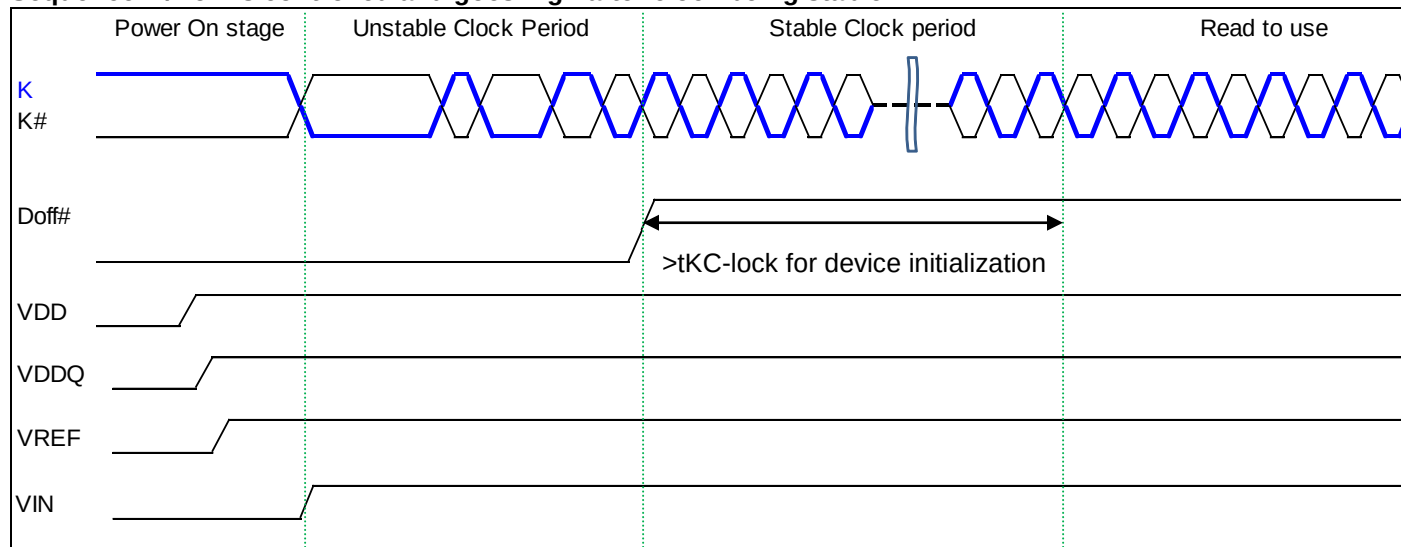
### Sequence1. /Doff is fixed low

After t<sub>KC-Lock</sub> cycle of stable clock, device is ready for normal operation.



Note) All inputs including clocks must be either logically High or Low during Power On stage. Timing above shows only one of cases.

### Sequence2. /Doff is controlled and goes high after clock being stable.



Note) All inputs including clocks must be either logically High or Low during Power On stage. Timing above shows only one of cases.

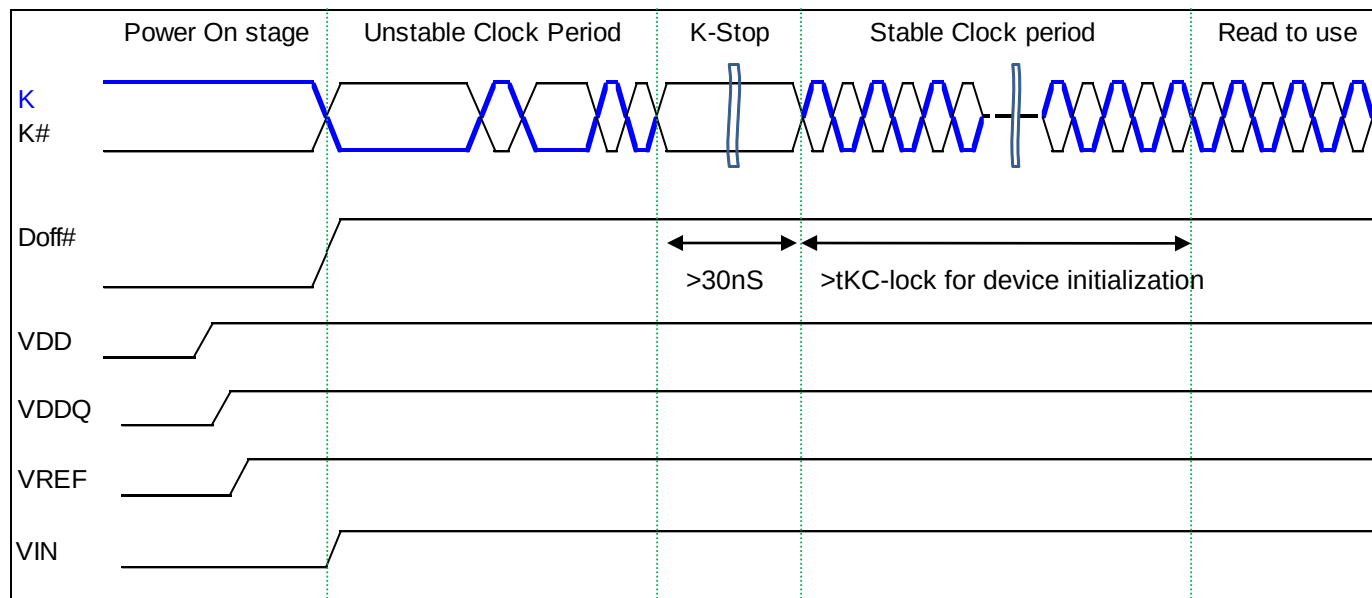
# IS61DDB41M18A IS61DDB451236A



## Sequence3. /Doff is controlled but goes high before clock being stable.

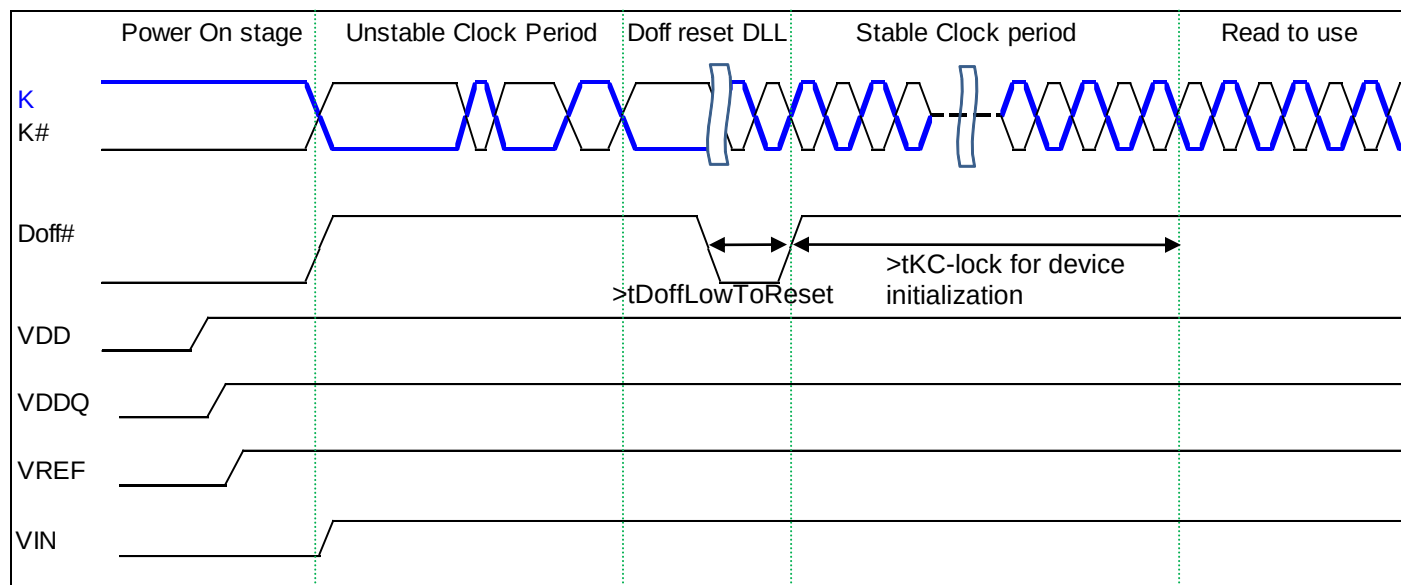
Because DLL has a risk to be locked with the unstable clock, DLL needs to be reset and locked with the stable input.

a) K-stop to reset. If K or K# stays at VIH or VIL for more than 30nS, DLL will be reset and ready to re-lock. In tKC-Lock period, DLL will be locked with a new stable value. Device can be ready for normal operation after that.



Note) All inputs including clocks must be either logically High or Low during Power On stage. Timing above shows only one of cases.

a) /Doff Low to reset. If /Doff toggled low to high, DLL will be reset and ready to re-lock. In tKC-Lock period, DLL will be locked with a new stable value. Device can be ready for normal operation after that.



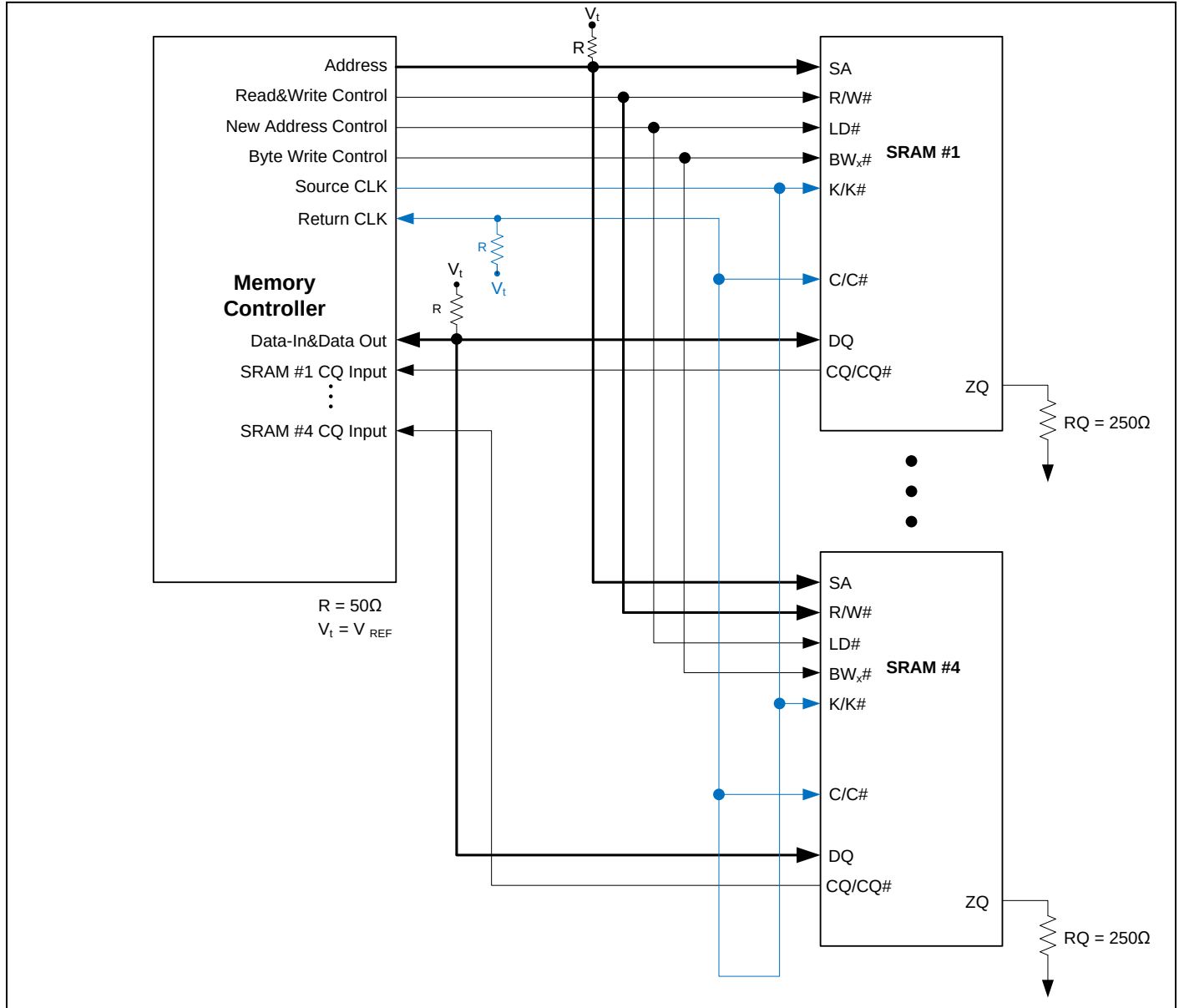
Note) Applying DLL reset sequences (sequence 3a, 3b) are also required when operating frequency is changed without power off.

Note) All inputs including clocks must be either logically High or Low during Power On stage. Timing above shows only one of cases.

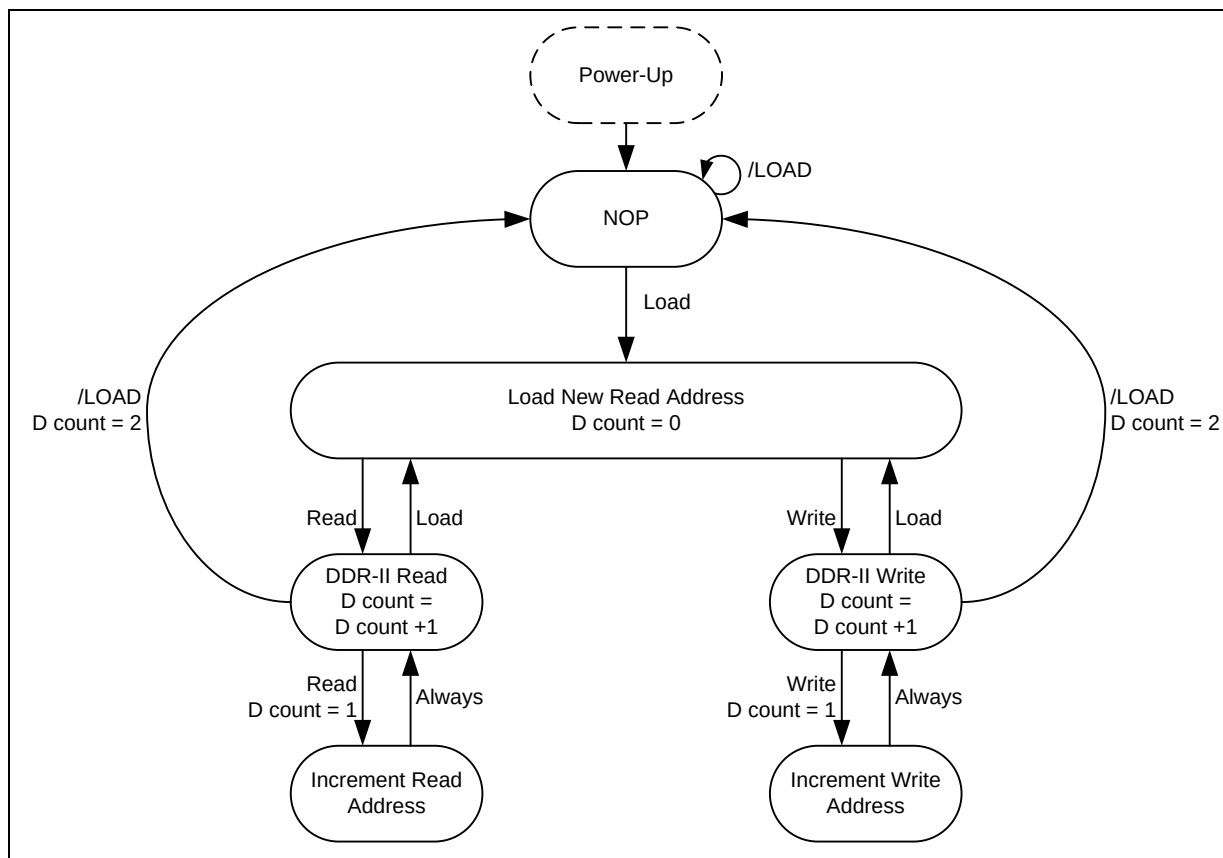


## Application Example

The following figure depicts an implementation of four 2M x 18 DDR-II SRAMs with common I/Os. In this application example, the second pair of C and C# clocks is delayed such that the return data meets the data setup and hold times at the bus master.



## State Diagram



### Notes:

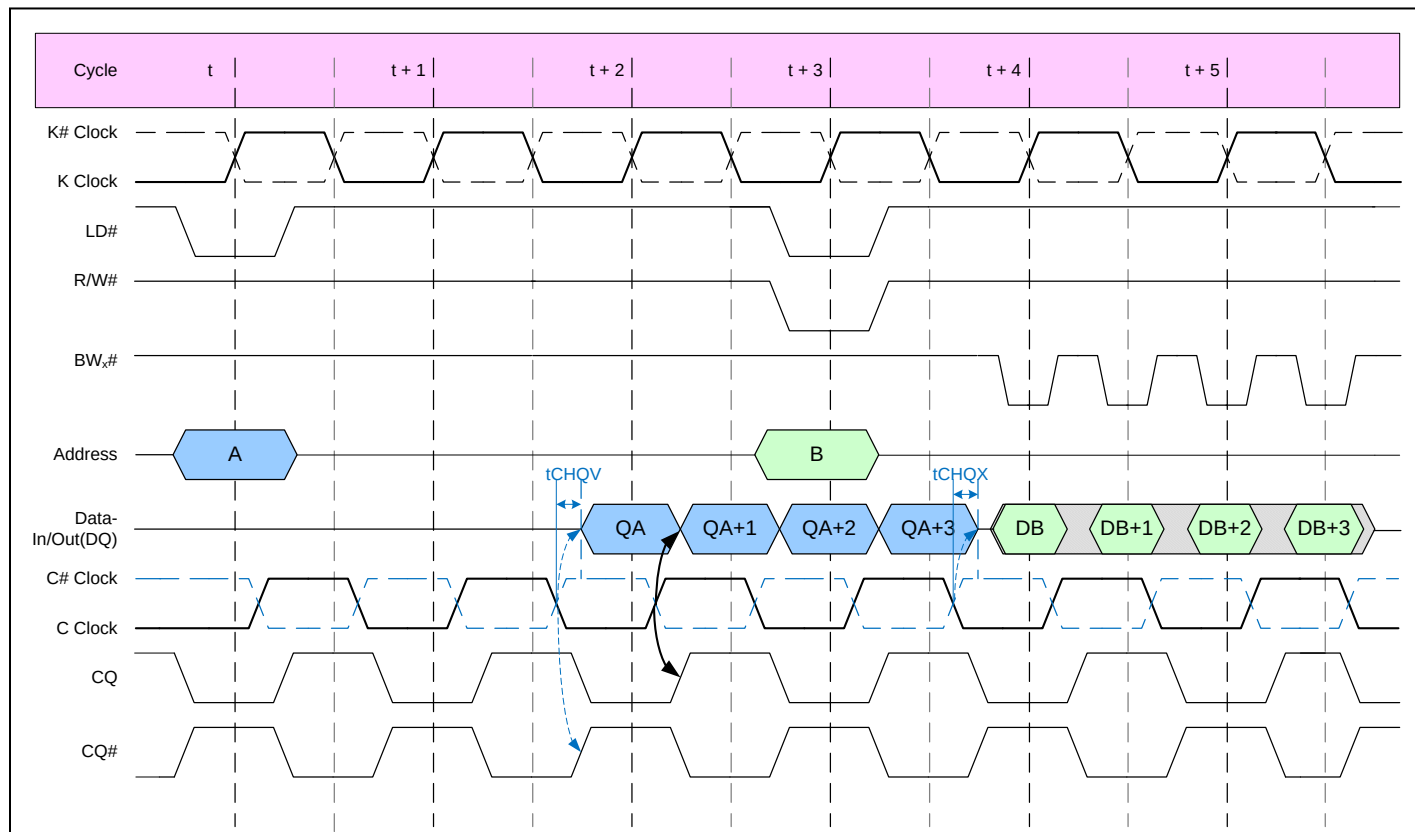
1. Internal burst counter is fixed as four-bit linear; that is when first address is A0+0, next internal burst addresses are A0+1, A0+2, and A0+3
2. Read refers to read active status with R/W# = High.
3. Write refers to write active status with R/W# = LOW.
4. Load refers to read new address active status with LD# = low.
5. Load is read new address inactive status with LD = high.

## Linear Burst Sequence Table

| Burst Sequence | Case1           |                 | Case2           |                 | Case3           |                 | Case4           |                 |
|----------------|-----------------|-----------------|-----------------|-----------------|-----------------|-----------------|-----------------|-----------------|
|                | SA <sub>1</sub> | SA <sub>0</sub> | SA <sub>1</sub> | SA <sub>0</sub> | SA <sub>1</sub> | SA <sub>0</sub> | SA <sub>1</sub> | SA <sub>0</sub> |
| First Address  | 0               | 0               | 0               | 1               | 1               | 0               | 1               | 1               |
| Second Address | 0               | 1               | 1               | 0               | 1               | 1               | 0               | 0               |
| Third Address  | 1               | 0               | 1               | 1               | 0               | 0               | 0               | 1               |
| Fourth Address | 1               | 1               | 0               | 0               | 0               | 1               | 1               | 0               |

## Timing Reference Diagram for Truth Table

The *Timing Reference Diagram for Truth Table* is helpful in understanding the *Clock and Write Truth Tables*, as it shows the cycle relationship between clocks, address, data in, data out, and control signals. Read command is issued at the beginning of cycle “t”. Write command is issued at the beginning of cycle “t+1”.



## Clock Truth Table

(Use the following table with the *Timing Reference Diagram for Truth Table*.)

| Mode               | Clock | Controls |      | Data Out / Data In               |                                 |                                  |                                 |
|--------------------|-------|----------|------|----------------------------------|---------------------------------|----------------------------------|---------------------------------|
|                    | K     | LD#      | R/W# | D <sub>B</sub>                   | D <sub>B+1</sub>                | D <sub>B+2</sub>                 | D <sub>B+3</sub>                |
| Stop Clock         | Stop  | X        | X    | Previous State                   | Previous State                  | Previous State                   | Previous State                  |
| No Operation (NOP) | L → H | H        | X    | High-Z                           | High-Z                          | High-Z                           | High-Z                          |
| Read A             | L → H | L        | H    | D <sub>OUT</sub> at C# (t+1.5) ↑ | D <sub>OUT</sub> at C (t+2.0) ↑ | D <sub>OUT</sub> at C# (t+2.5) ↑ | D <sub>OUT</sub> at C (t+3.0) ↑ |
| Write B            | L → H | L        | L    | D <sub>IN</sub> at K (t+4.0) ↑   | D <sub>IN</sub> at K# (t+4.5) ↑ | D <sub>IN</sub> at K (t+5.0) ↑   | D <sub>IN</sub> at K# (t+5.5) ↑ |

Notes:

1. X = “don’t care”; H = logic “1”; L = logic “0”.
2. A read operation is started when control signal R/W# is active high.
3. A write operation is started when control signal R/W# is active low.
4. Before entering into stop clock, all pending read and write commands must be completed.
5. For timing definitions, refer to the *AC Timing Characteristics* table. Signals must meet AC specifications at timings indicated in parenthesis with respect to switching clocks K, K#, C, and C#.

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## x18 Write Truth Table

(Use the following table with the *Timing Reference Diagram for Truth Table*.)

| Operation       | K (t+1.0) | K (t+1.5) | K (t+2.0) | K (t+2.5) | BW <sub>0</sub> | BW <sub>1</sub> | D <sub>B</sub> | D <sub>B+1</sub> | D <sub>B+2</sub> | D <sub>B+3</sub> |
|-----------------|-----------|-----------|-----------|-----------|-----------------|-----------------|----------------|------------------|------------------|------------------|
| Write Byte 0    | L → H     |           |           |           | L               | H               | D0-8 (t+4.0)   |                  |                  |                  |
| Write Byte 1    | L → H     |           |           |           | H               | L               | D9-17 (t+4.0)  |                  |                  |                  |
| Write All Bytes | L → H     |           |           |           | L               | L               | D0-17 (t+4.0)  |                  |                  |                  |
| Abort Write     | L → H     |           |           |           | H               | H               | Don't Care     |                  |                  |                  |
| Write Byte 0    |           | L → H     |           |           | L               | H               |                | D0-8 (t+4.5)     |                  |                  |
| Write Byte 1    |           | L → H     |           |           | H               | L               |                | D9-17 (t+4.5)    |                  |                  |
| Write All Bytes |           | L → H     |           |           | L               | L               |                | D0-17 (t+4.5)    |                  |                  |
| Abort Write     |           | L → H     |           |           | H               | H               |                | Don't Care       |                  |                  |
| Write Byte 0    |           |           | L → H     |           | L               | H               |                |                  | D0-8 (t+5.0)     |                  |
| Write Byte 1    |           |           | L → H     |           | H               | L               |                |                  | D9-17 (t+5.0)    |                  |
| Write All Bytes |           |           | L → H     |           | L               | L               |                |                  | D0-17 (t+5.0)    |                  |
| Abort Write     |           |           | L → H     |           | H               | H               |                |                  | Don't Care       |                  |
| Write Byte 0    |           |           |           | L → H     | L               | H               |                |                  |                  | D0-8 (t+5.5)     |
| Write Byte 1    |           |           |           | L → H     | H               | L               |                |                  |                  | D9-17 (t+5.5)    |
| Write All Bytes |           |           |           | L → H     | L               | L               |                |                  |                  | D0-17 (t+5.5)    |
| Abort Write     |           |           |           | L → H     | H               | H               |                |                  |                  | Don't Care       |

Notes:

- For all cases, R/W# needs to be active low during the rising edge of K occurring at time t.
- For timing definitions refer to the *AC Timing Characteristics* table. Signals must meet AC specifications with respect to switching clocks K and K#.

### x36 Write Truth Table

(Use the following table with the *Timing Reference Diagram for Truth Table*.)

| Operation       | K (t+1.0) | K (t+1.5) | K (t+2.0) | K (t+2.5) | BW <sub>0</sub> | BW <sub>1</sub> | BW <sub>2</sub> | BW <sub>3</sub> | D <sub>B</sub> | D <sub>B+1</sub> | D <sub>B+2</sub> | D <sub>B+3</sub> |
|-----------------|-----------|-----------|-----------|-----------|-----------------|-----------------|-----------------|-----------------|----------------|------------------|------------------|------------------|
| Write Byte 0    | L → H     |           |           |           | L               | H               | H               | H               | D0-8 (t+4.0)   |                  |                  |                  |
| Write Byte 1    | L → H     |           |           |           | H               | L               | H               | H               | D9-17 (t+4.0)  |                  |                  |                  |
| Write Byte 2    | L → H     |           |           |           | H               | H               | L               | H               | D18-26 (t+4.0) |                  |                  |                  |
| Write Byte 3    | L → H     |           |           |           | H               | H               | H               | L               | D27-35 (t+4.0) |                  |                  |                  |
| Write All Bytes | L → H     |           |           |           | L               | L               | L               | L               | D0-35 (t+4.0)  |                  |                  |                  |
| Abort Write     | L → H     |           |           |           | H               | H               | H               | H               | Don't Care     |                  |                  |                  |
| Write Byte 0    |           | L → H     |           |           | L               | H               | H               | H               |                | D0-8 (t+4.5)     |                  |                  |
| Write Byte 1    |           | L → H     |           |           | H               | L               | H               | H               |                | D9-17 (t+4.5)    |                  |                  |
| Write Byte 2    |           | L → H     |           |           | H               | H               | L               | H               |                | D18-26 (t+4.5)   |                  |                  |
| Write Byte 3    |           | L → H     |           |           | H               | H               | H               | L               |                | D27-35 (t+4.5)   |                  |                  |
| Write All Bytes |           | L → H     |           |           | L               | L               | L               | L               |                | D0-35 (t+4.5)    |                  |                  |
| Abort Write     |           | L → H     |           |           | H               | H               | H               | H               |                | Don't Care       |                  |                  |
| Write Byte 0    |           |           | L → H     |           | L               | H               | H               | H               |                |                  | D0-8 (t+5.0)     |                  |
| Write Byte 1    |           |           | L → H     |           | H               | L               | H               | H               |                |                  | D9-17 (t+5.0)    |                  |
| Write Byte 2    |           |           | L → H     |           | H               | H               | L               | H               |                |                  | D18-26 (t+5.0)   |                  |
| Write Byte 3    |           |           | L → H     |           | H               | H               | H               | L               |                |                  | D27-35 (t+5.0)   |                  |
| Write All Bytes |           |           | L → H     |           | L               | L               | L               | L               |                |                  | D0-35 (t+5.0)    |                  |
| Abort Write     |           |           | L → H     |           | H               | H               | H               | H               |                |                  | Don't Care       |                  |
| Write Byte 0    |           |           |           | L → H     | L               | H               | H               | H               |                |                  |                  | D0-8 (t+5.5)     |
| Write Byte 1    |           |           |           | L → H     | H               | L               | H               | H               |                |                  |                  | D9-17 (t+5.5)    |
| Write Byte 2    |           |           |           | L → H     | H               | H               | L               | H               |                |                  |                  | D18-26 (t+5.5)   |
| Write Byte 3    |           |           |           | L → H     | H               | H               | H               | L               |                |                  |                  | D27-35 (t+5.5)   |
| Write All Bytes |           |           |           | L → H     | L               | L               | L               | L               |                |                  |                  | D0-35 (t+5.5)    |
| Abort Write     |           |           |           | L → H     | H               | H               | H               | H               |                |                  |                  | Don't Care       |

#### Notes:

- For all cases, R/W# needs to be active low during the rising edge of K occurring at time t.
- For timing definitions refer to the *AC Timing Characteristics* table. Signals must meet AC specifications with respect to switching clocks K and K#.

## Electrical Specifications

### Absolute Maximum Ratings

| Parameter                | Symbol     | Min  | Max          | Units |
|--------------------------|------------|------|--------------|-------|
| Power Supply Voltage     | $V_{DD}$   | -0.5 | 2.9          | V     |
| I/O Power Supply Voltage | $V_{DDQ}$  | -0.5 | 2.9          | V     |
| DC Input Voltage         | $V_{IN}$   | -0.5 | $V_{DD}+0.3$ | V     |
| Data Out Voltage         | $V_{DOUT}$ | -0.5 | 2.6          | V     |
| Junction Temperature     | $T_J$      | -    | 110          | °C    |
| Storage Temperature      | $T_{STG}$  | -55  | +125         | °C    |

Note:

Stresses greater than those listed in this table can cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this datasheet is not implied. Exposure to absolute maximum rating conditions for extended periods may affect reliability.

### Operating Temperature Range

| Temperature Range | Symbol | Min | Max | Units |
|-------------------|--------|-----|-----|-------|
| Commercial        | $T_A$  | 0   | +70 | °C    |
| Industrial        | $T_A$  | -40 | +85 | °C    |

### DC Electrical Characteristics

(Over the Operating Temperature Range,  $V_{DD}=1.8V\pm5\%$ )

| Parameter                                                                                                                 | Symbol                                 | Min           | Max               | Units   | Notes |
|---------------------------------------------------------------------------------------------------------------------------|----------------------------------------|---------------|-------------------|---------|-------|
| x36 Average Power Supply Operating Current<br>( $I_{OUT}=0$ , $V_{IN}=V_{IH}$ or $V_{IL}$ )                               | $I_{DD30}$<br>$I_{DD33}$<br>$I_{DD40}$ | -             | 620<br>580<br>550 | mA      | 1,2   |
| x18 Average Power Supply Operating Current<br>( $I_{OUT}=0$ , $V_{IN}=V_{IH}$ or $V_{IL}$ )                               | $I_{DD30}$<br>$I_{DD33}$<br>$I_{DD40}$ | -             | 570<br>530<br>500 | mA      | 1,2   |
| Power Supply Standby Current<br>( $R=V_{IH}$ , $W=V_{IH}$ . All other inputs= $V_{IH}$ or $V_{IL}$ , $I_{IH}=0$ )         | $I_{SB30}$<br>$I_{SB33}$<br>$I_{SB40}$ | -             | 310<br>295<br>280 | mA      | 1,2   |
| Input leakage current<br>( $0 \leq V_{IN} \leq V_{DDQ}$ for all input balls except $V_{REF}$ , ZQ, TCK, TMS, TDI ball)    | $I_{LI}$                               | -2            | +2                | $\mu A$ | 3     |
| Output leakage current<br>( $0 \leq V_{OUT} \leq V_{DDQ}$ for all output balls except TDO ball; Output must be disabled.) | $I_{LO}$                               | -2            | +2                | $\mu A$ |       |
| Output "high" level voltage ( $I_{OH}=-100\mu A$ , Nominal ZQ)                                                            | $V_{OH}$                               | $V_{DDQ}-0.2$ | $V_{DDQ}$         | V       |       |
| Output "low" level voltage ( $I_{OL}=100\mu A$ , Nominal ZQ)                                                              | $V_{OL}$                               | $V_{SS}$      | $V_{SS}+0.2$      | V       |       |

Notes:

- $I_{OUT}$  = chip output current.
- The numeric suffix indicates the part operating at speed, as indicated in *AC Timing Characteristics* table (that is,  $I_{DD25}$  indicates 2.5ns cycle time).
- DOFF# Ball does not follow this spec,  $I_{LI} = \pm 5\mu A$

## Recommended DC Operating Conditions

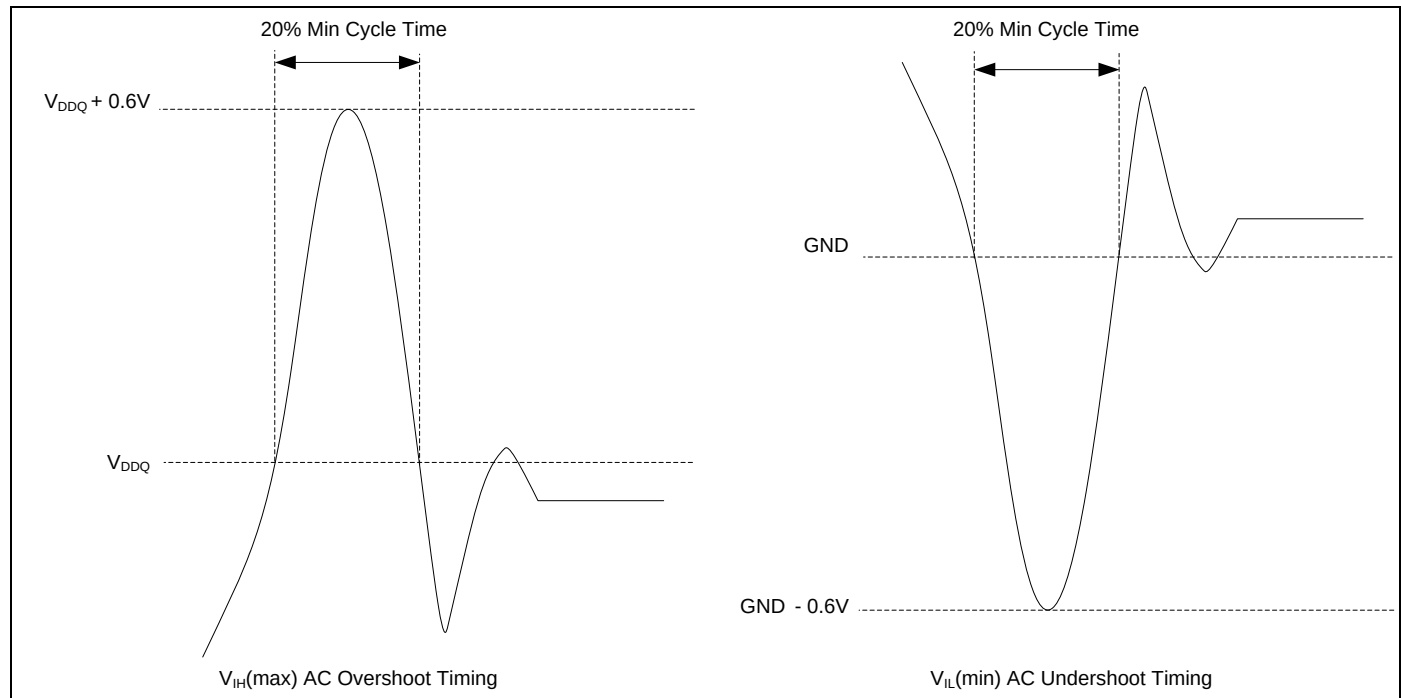
(Over the Operating Temperature Range)

| Parameter                    | Symbol       | Min           | Typical | Max           | Units | Notes |
|------------------------------|--------------|---------------|---------|---------------|-------|-------|
| Supply Voltage               | $V_{DD}$     | 1.8–5%        | 1.8     | 1.8+5%        | V     | 1     |
| Output Driver Supply Voltage | $V_{DDQ}$    | 1.4           | 1.5     | $V_{DD}$      | V     | 1     |
| Input High Voltage           | $V_{IH}$     | $V_{REF}+0.1$ | -       | $V_{DDQ}+0.2$ | V     | 1, 2  |
| Input Low Voltage            | $V_{IL}$     | -0.2          | -       | $V_{REF}-0.1$ | V     | 1, 3  |
| Input Reference Voltage      | $V_{REF}$    | 0.68          | 0.75    | 0.95          | V     | 1, 5  |
| Clock Signal Voltage         | $V_{IN-CLK}$ | -0.2          | -       | $V_{DDQ}+0.2$ | V     | 1, 4  |

Notes:

1. All voltages are referenced to  $V_{SS}$ . All  $V_{DD}$ ,  $V_{DDQ}$ , and  $V_{SS}$  pins must be connected.
2.  $V_{IH}(\text{max})$  AC = See *Overshoot and Undershoot Timings*.
3.  $V_{IL}(\text{min})$  AC = See *Overshoot and Undershoot Timings*.
4.  $V_{IN-CLK}$  specifies the maximum allowable DC excursions of each clock (K,K#,C and C#).
5. Peak-to-peak AC component superimposed on  $V_{REF}$  may not exceed 5% of  $V_{REF}$ .

## Overshoot and Undershoot Timings



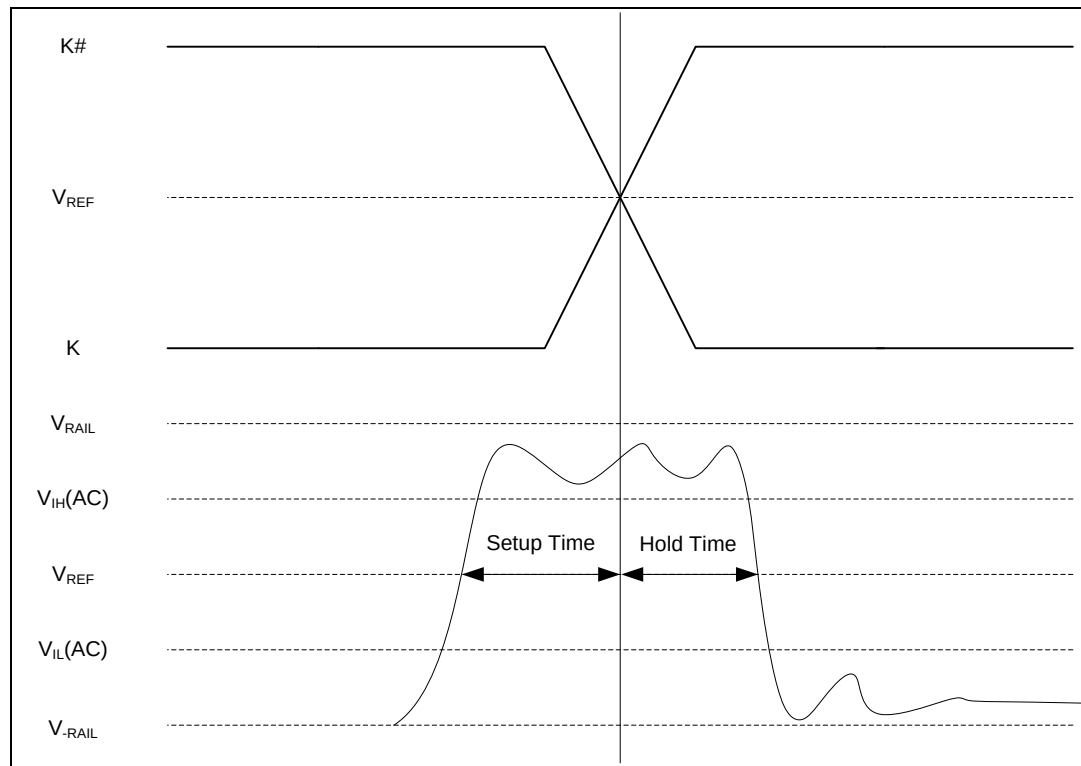
## Typical AC Input Characteristics

| Parameter              | Symbol           | Min           | Max           | Units | Notes      |
|------------------------|------------------|---------------|---------------|-------|------------|
| AC Input Logic HIGH    | $V_{IH}(AC)$     | $V_{REF}+0.2$ |               | V     | 1, 2, 3, 4 |
| AC Input Logic LOW     | $V_{IL}(AC)$     |               | $V_{REF}-0.2$ | V     | 1, 2, 3, 4 |
| Clock Input Logic HIGH | $V_{IH-CLK}(AC)$ | $V_{REF}+0.2$ |               | V     | 1, 2, 3    |
| Clock Input Logic LOW  | $V_{IL-CLK}(AC)$ |               | $V_{REF}-0.2$ | V     | 1, 2, 3    |

### Notes:

1. The peak-to-peak AC component superimposed on  $V_{REF}$  may not exceed 5% of the DC component of  $V_{REF}$ .
2. Performance is a function of  $V_{IH}$  and  $V_{IL}$  levels to clock inputs.
3. See the *AC Input Definition* diagram.
4. See the *AC Input Definition* diagram. The signals should swing monotonically with no steps rail-to-rail with input signals never ringing back past  $V_{IH}(AC)$  and  $V_{IL}(AC)$  during the input setup and input hold window.  $V_{IH}(AC)$  and  $V_{IL}(AC)$  are used for timing purposes only.

## AC Input Definition



## PBGA Thermal Characteristics

| Parameter                                                  | Symbol          | 13x15 BGA | 15x17 BGA | Units         |
|------------------------------------------------------------|-----------------|-----------|-----------|---------------|
| Thermal resistance (junction to ambient at airflow = 1m/s) | $R_{\theta JA}$ | 19.6      | 18.0      | $^{\circ}C/W$ |
| Thermal resistance (junction to pins)                      | $R_{\theta JB}$ | 4.02      | 3.30      | $^{\circ}C/W$ |
| Thermal resistance (junction to case)                      | $R_{\theta JC}$ | 4.53      | 4.20      | $^{\circ}C/W$ |

Note: these parameters are guaranteed by design and tested by a sample basis only.



## Pin Capacitance

| Parameter                                  | Symbol        | Test Condition                                                                          | Max | Units |
|--------------------------------------------|---------------|-----------------------------------------------------------------------------------------|-----|-------|
| Input or output capacitance except DQ pins | $C_{IN}, C_O$ | $T_A = 25^\circ\text{C}, f = 1\text{ MHz}, V_{DD} = 1.8\text{V}, V_{DDQ} = 1.5\text{V}$ | 5   | pF    |
| DQ capacitance (DQ0–DQx)                   | $C_{DQ}$      |                                                                                         | 6   | pF    |
| Clocks Capacitance (K, K, C, C)            | $C_{CLK}$     |                                                                                         | 4   | pF    |

Note: these parameters are guaranteed by design and tested by a sample basis only.

## Programmable Impedance Output Driver DC Electrical Characteristics

(Over the Operating Temperature Range,  $V_{DD}=1.8\text{V}\pm 5\%$ ,  $V_{DDQ}=1.5\text{V}/1.8\text{V}$ )

| Parameter                 | Symbol   | Min                | Max                | Units | Notes |
|---------------------------|----------|--------------------|--------------------|-------|-------|
| Output Logic HIGH Voltage | $V_{OH}$ | $V_{DDQ}/2 - 0.12$ | $V_{DDQ}/2 + 0.12$ | V     | 1, 3  |
| Output Logic LOW Voltage  | $V_{OL}$ | $V_{DDQ}/2 - 0.12$ | $V_{DDQ}/2 + 0.12$ | V     | 2, 3  |

Notes:

1. For  $175\Omega \leq R_Q \leq 350\Omega$ :

$$|I_{OH}| = \frac{\left(\frac{V_{DDQ}}{2}\right)}{\left(\frac{R_Q}{5}\right)}$$

2. For  $175\Omega \leq R_Q \leq 350\Omega$ :

$$|I_{OL}| = \frac{\left(\frac{V_{DDQ}}{2}\right)}{\left(\frac{R_Q}{5}\right)}$$

3. Parameter Tested with  $R_Q=250\Omega$  and  $V_{DDQ}=1.5\text{V}$

## AC Test Conditions

(Over the Operating Temperature Range,  $V_{DD}=1.8\text{V}\pm 5\%$ ,  $V_{DDQ}=1.5\text{V}/1.8\text{V}$ )

| Parameter                         | Symbol    | Conditions    | Units | Notes |
|-----------------------------------|-----------|---------------|-------|-------|
| Output Drive Power Supply Voltage | $V_{DDQ}$ | 1.5/1.8       | V     |       |
| Input Logic HIGH Voltage          | $V_{IH}$  | $V_{REF}+0.5$ | V     |       |
| Input Logic LOW Voltage           | $V_{IL}$  | $V_{REF}-0.5$ | V     |       |
| Input Reference Voltage           | $V_{REF}$ | 0.75/0.9      | V     |       |
| Input Rise Time                   | $T_R$     | 2.0           | V/ns  |       |
| Input Fall Time                   | $T_F$     | 2.0           | V/ns  |       |
| Output Timing Reference Level     |           | $V_{REF}$     | V     |       |
| Clock Reference Level             |           | $V_{REF}$     | V     |       |
| Output Load Conditions            |           |               |       | 1, 2  |

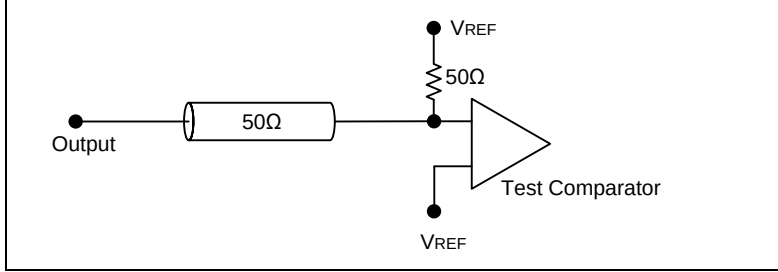
Notes:

1. See AC Test Loading.  
2. Parameter Tested with  $R_Q=250\Omega$  and  $V_{DDQ}=1.5\text{V}$

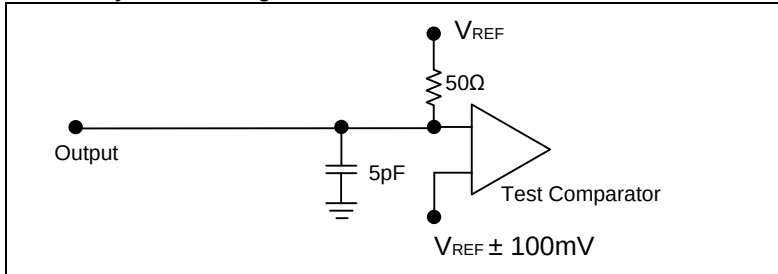
# IS61DDB41M18A IS61DDB451236A

## AC TEST LOADING

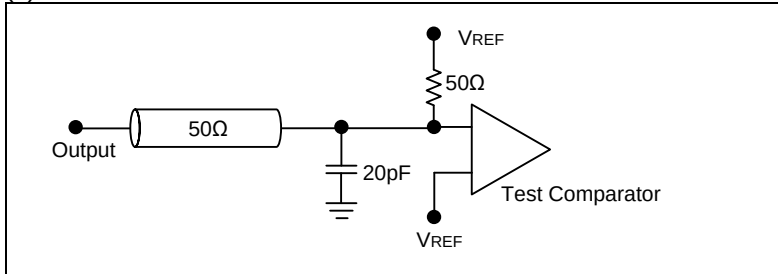
(a) Unless otherwise noted, AC test loading assume this condition.



(b) tCHQZ and tCHQX1 are specified with 5pF load capacitance and measured when transition occurs  $\pm 100\text{mV}$  from the steady state voltage.



(c) TDO



## AC Timing Characteristics

(Over the Operating Temperature Range,  $V_{DD}=1.8V\pm5\%$ ,  $V_{DDQ}=1.5V/1.8V$ )

| Parameter                                                                             | Symbol          | 30 (333MHz) |      | 33 (300MHz) |      | 40 (250MHz) |      | unit   | notes |
|---------------------------------------------------------------------------------------|-----------------|-------------|------|-------------|------|-------------|------|--------|-------|
|                                                                                       |                 | Min         | Max  | Min         | Max  | Min         | Max  |        |       |
| Clock                                                                                 |                 |             |      |             |      |             |      |        |       |
| Clock Cycle Time (K, K#,C,C#)                                                         | tKHKH           | 3.00        | 8.4  | 3.33        | 8.4  | 4.00        | 8.4  | ns     |       |
| Clock Phase Jitter (K, K#,C,C#)                                                       | tKC var         |             | 0.3  |             | 0.3  |             | 0.3  | ns     | 4     |
| Clock High Time (K, K#,C,C#)                                                          | tKHKL           | 0.4         |      | 0.4         |      | 0.4         |      | cycle  |       |
| Clock Low Time (K, K#,C,C#)                                                           | tKLKH           | 0.4         |      | 0.4         |      | 0.4         |      | cycle  |       |
| Clock to Clock (K <sub>H</sub> → K <sub>#H</sub> , C <sub>H</sub> → C <sub>#H</sub> ) | tKHK#H          | 1.35        |      | 1.50        |      | 1.80        |      | ns     |       |
| Clock to Data Clock (K > C, K# > C#)                                                  | tKHCH           | 0           | 1.35 | 0           | 1.48 | 0           | 1.8  | ns     | 5     |
| DLL Lock Time (K,C)                                                                   | tKC lock        | 1024        |      | 1024        |      | 1024        |      | cycles | 5     |
| Doff Low period to DLL reset                                                          | tDoffLowToReset | 5           |      | 5           |      | 5           |      | ns     |       |
| K static to DLL reset                                                                 | tKCreset        | 30          |      | 30          |      | 30          |      | ns     |       |
| Output Times                                                                          |                 |             |      |             |      |             |      |        |       |
| C,C# High to Output Valid                                                             | tCHQV           |             | 0.45 |             | 0.45 |             | 0.45 | ns     | 1,3   |
| C,C# High to Output Hold                                                              | tCHQX           | -0.45       |      | -0.45       |      | -0.45       |      | ns     | 1,3   |
| C,C# High to Echo Clock Valid                                                         | tCHCQV          |             | 0.45 |             | 0.45 |             | 0.45 | ns     | 1     |
| C,C# High to Echo Clock Hold                                                          | tCHCQX          | -0.45       |      | -0.45       |      | -0.45       |      | ns     | 1     |
| CQ, CQ# High to Output Valid                                                          | tCQHQV          |             | 0.30 |             | 0.30 |             | 0.30 | ns     | 1,3   |
| CQ, CQ# High to Output Hold                                                           | tCQHQX          | -0.30       |      | -0.30       |      | -0.30       |      | ns     | 1,3   |
| C,C# High to Output High-Z                                                            | tCHQZ           |             | 0.45 |             | 0.45 |             | 0.45 | ns     | 1,3   |
| C,C# High to Output Low-Z                                                             | tCHQX1          | -0.45       |      | -0.45       |      | -0.45       |      | ns     | 1,3   |
| Setup Times                                                                           |                 |             |      |             |      |             |      |        |       |
| Address valid to K rising edge                                                        | tAVKH           | 0.40        |      | 0.40        |      | 0.40        |      | ns     | 2     |
| LD#,R/L# control inputs valid to K rising edge                                        | tIVKH           | 0.40        |      | 0.40        |      | 0.40        |      | ns     | 2     |
| BW <sub>x</sub> # control inputs valid to K rising edge                               | tIVKH2          | 0.30        |      | 0.30        |      | 0.30        |      | ns     | 2     |
| Data-in valid to K, K# rising edge                                                    | tDVKH           | 0.30        |      | 0.30        |      | 0.30        |      | ns     | 2     |
| Hold Times                                                                            |                 |             |      |             |      |             |      |        |       |
| K rising edge to address hold                                                         | tKHAX           | 0.40        |      | 0.40        |      | 0.40        |      | ns     | 2     |
| K rising edge to LD#,R/L# control inputs hold                                         | tKHIX           | 0.40        |      | 0.40        |      | 0.40        |      | ns     | 2     |
| K rising edge to BW <sub>x</sub> # control inputs hold                                | tKHIX2          | 0.30        |      | 0.30        |      | 0.30        |      | ns     | 2     |
| K, K# rising edge to data-in hold                                                     | tKHDX           | 0.30        |      | 0.30        |      | 0.30        |      | ns     | 2     |

### Notes:

1. All address inputs must meet the specified setup and hold times for all latching clock edges.
2. During normal operation, VIH, VIL, TRISE, and TFALL of inputs must be within 20% of VIH, VIL, TRISE, and TFALL of clock.
3. If C, C are tied high, then K, K become the references for C, C timing parameters.
4. Clock phase jitter is the variance from clock rising edge to the next expected clock rising edge.
5.  $V_{DD}$  slew rate must be less than 0.1V DC per 50ns for DLL lock retention. DLL lock time begins once  $V_{DD}$  and input clock are stable.
6. The data sheet parameters reflect tester guard bands and test setup variations.
7. To avoid bus contention, at a given voltage and temperature tCHQX1 is bigger than tCHQZ. The specs as shown do not imply bus contention because tCHQX1 is a MIN parameter that is worst case at totally different test conditions (0 C, 1.9V) than tCHQZ, which is a MAX parameter (worst case at 70 C, 1.7V) It is not possible for two SRAMs on the same board to be at such different voltage and temperature.

2. Outputs are disabled (high impedance) one clock cycle after a NOP.
3. The NOP cycle is not necessary for correct device operation, however.

## **IEEE 1149.1 Serial Boundary Scan of JTAG**

These SRAMs incorporate a serial boundary scan Test Access Port (TAP) controller in 165 FBGA package. That is fully compliant with IEEE Standard 1149.1-2001. The TAP controller operates using standard 1.8 V interface logic levels.

### **Disabling the JTAG feature**

These SRAMs operate without using the JTAG feature. To disable the TAP controller, TCK must be tied Low (VSS) to prevent clocking of the device. TDI and TMS are internally pulled up and may be unconnected. They may alternatively be connected to VDD through a pull up resistor. TDO must be left unconnected. Upon power up, the device comes up in a reset state, which does not interfere with the operation of the device.

### **Test Access Port Signal List:**

#### **Test Clock (TCK)**

The test clock is to operate only TAP controller. All inputs are captured on the rising edge of TCK. All outputs are driven from the falling edge of TCK.

#### **Test Mode Select (TMS)**

The TMS input is to set commands of the TAP controller and is sampled on the rising edge of TCK. This pin can be left unconnected at SRAM operation. The pin is pulled up internally to keep logic high level.

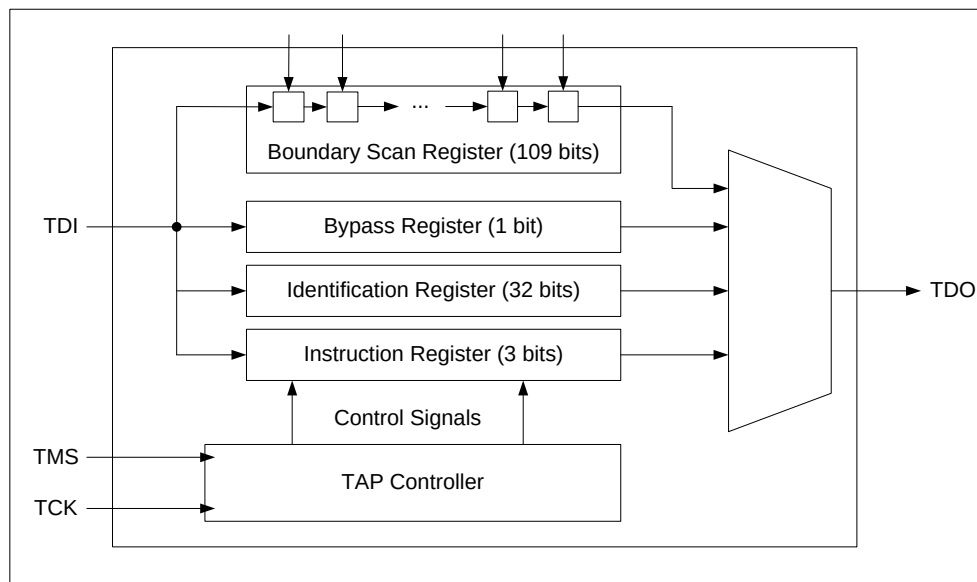
#### **Test Data-In (TDI)**

The TDI pin is to receive serially input information into the instruction and data registers. It can be connected to the input of any of the registers. The register between TDI and TDO is chosen by the instruction that is loaded into the TAP instruction register. For information on loading the instruction register (Refer to the TAP Controller State Diagram). TDI is internally pulled up and can be unconnected at SRAM. TDI is connected to the most significant bit (MSB) on any register.

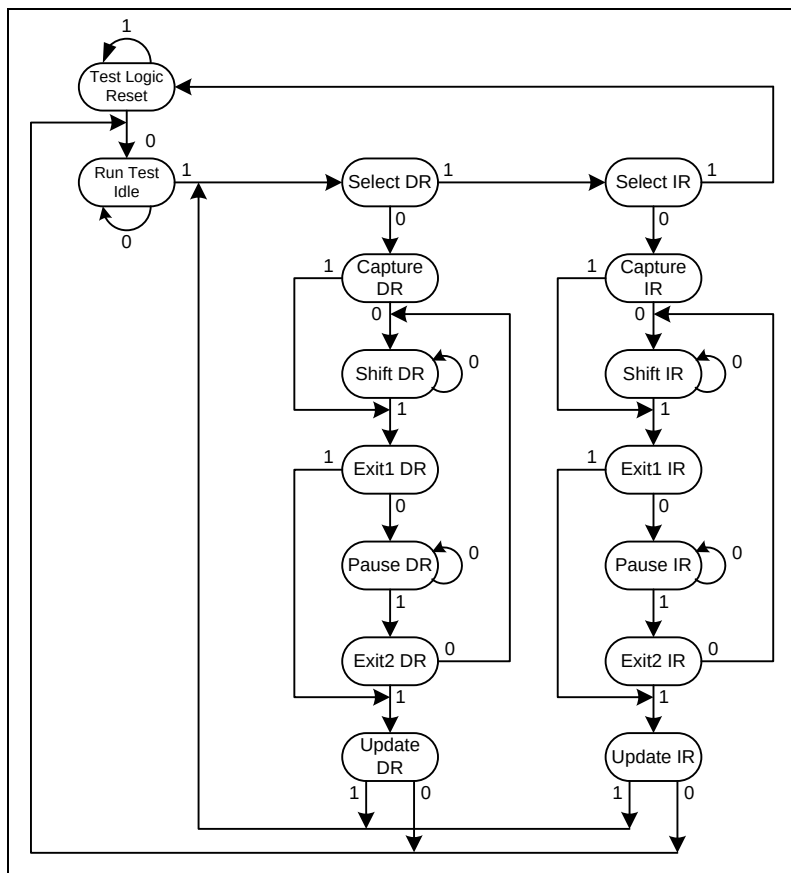
#### **Test Data-Out (TDO)**

The TDO pin is to drive serially clock data out from the JTAG registers. The output is active, depending upon the current state of the TAP state machine (Refer to instruction codes). The output changes on the falling edge of TCK. TDO is connected to the least significant bit (LSB) of any register.

## TAP Controller State and Block Diagram



## TAP Controller State Machine



## **Performing a TAP Reset**

A Reset is performed by forcing TMS HIGH (VDD) for five rising edges of TCK. This Reset does not affect the operation of the SRAM and can be performed while the SRAM is operating. At power up, the TAP is reset internally to ensure that TDO comes up in a High Z state.

## **TAP Registers**

Registers are connected between the TDI and TDO pins and allow data to be scanned into and out of the SRAM test circuitry. Only one register can be selected at a time through the instruction registers. Data is serially loaded into the TDI pin on the rising edge of TCK and output on the TDO pin on the falling edge of TCK.

### **Instruction Register**

This register is loaded during the update-IR state of the TAP controller. Three-bit instructions can be serially loaded into the instruction register. At power-up, the instruction register is loaded with the IDCODE instruction. It is also loaded with the IDCODE instruction if the controller is placed in a reset state as described in the previous section. When the TAP controller is in the capture-IR state, the two LSBs are loaded with a binary "01" pattern to allow for fault isolation of the board-level serial test data path.

### **Bypass Register**

The bypass register is a single-bit register that can be placed between the TDI and TDO balls. It is to skip certain chips without serial boundary scan. This allows data to be shifted through the SRAM with minimal delay. The bypass register is set LOW ( $V_{SS}$ ) when the BYPASS instruction is executed.

### **Boundary Scan Register**

The boundary scan register is connected to all the input and output balls on the SRAM. Several No Connected(NC) balls are also included in the scan register to reserve other product options. The boundary scan register is loaded with the contents of the SRAM input and output ring when the TAP controller is in the capture-DR state and is then placed between the TDI and TDO balls when the controller is moved to the shift-DR state. The EXTEST, SAMPLE/PRELOAD, and SAMPLE Z instructions can be used to capture the contents of the input and output ring. Each bit corresponds to one of the balls on the SRAM package. The MSB of the register is connected to TDI, and the LSB is connected to TDO.

### **Identification (ID) Register**

The ID register is loaded with a vendor-specific, 32-bit code during the Capture-DR state when the IDCODE command is loaded in the instruction register. The IDCODE is hardwired into the SRAM and can be shifted out when the TAP controller is in the shift-DR state. The ID register has a vendor ID code and other information

## **TAP Instruction Set**

TAP Instruction Set is available to set eight instructions with the three bit instruction register and all combinations are listed in the TAP Instruction Code Table. Three of listed instructions on this table are reserved and must not be used. Instructions are loaded serially into the TAP controller during the Shift-IR state when the instruction register is placed between TDI and TDO. To execute an instruction once it is shifted in, the TAP controller must be moved into the Update-IR state.

### **IDCODE**

The IDCODE instruction causes a vendor-specific, 32-bit code to be loaded into the instruction register. It also places the instruction register between the TDI and TDO balls and allows the IDCODE to be shifted out of the device when the TAP controller enters the shift-DR state. The IDCODE instruction is loaded into the instruction register upon power-up or whenever the TAP controller is given a test logic reset state.

## **SAMPLE Z**

The SAMPLE Z instruction connects the boundary scan register between the TDI and TDO pins when the TAP controller is in a Shift-DR state. The SAMPLE Z command puts the output bus into a High Z state until the next command is supplied during the Update IR state.

## **SAMPLE/PRELOAD**

SAMPLE/PRELOAD is a IEEE 1149.1 basic instruction which connects the boundary scan register between the TDI and TDO pins when the TAP controller is in a Shift-DR state.. A snapshot of data on the inputs and output balls is captured in the boundary scan register when the TAP controller is in a Shift-DR state. The user must be aware that the TAP controller clock can only operate at a frequency up to 20 MHz, while the SRAM clock operates significantly faster. Because there is a large difference between the clock frequencies, it is possible that during the capture-DR state, an input or output will undergo a transition. The TAP may then try to capture a signal while in transition. This will not harm the device, but there is no guarantee as to the value that will be captured. Repeatable results may not be possible. To ensure that the boundary scan register will capture the correct value of a signal, the SRAM signal must be stabilized long enough to meet the TAP controller's capture setup plus hold time. The SRAM clock input might not be captured correctly if there is no way in a design to stop (or slow) the clock during a SAMPLE/ PRELOAD instruction. If this is an issue, it is still possible to capture all other signals and simply ignore the value of the CK and CK# captured in the boundary scan register. Once the data is captured, it is possible to shift out the data by putting the TAP into the shift-DR state. This places the boundary scan register between the TDI and TDO balls.

PRELOAD places an initial data pattern at the latched parallel outputs of the boundary scan register cells before the selection of another boundary scan test operation. The shifting of data for the SAMPLE and PRELOAD phases can occur concurrently when required, that is, while the data captured is shifted out, the preloaded data can be shifted in.

## **BYPASS**

When the BYPASS instruction is loaded in the instruction register and the TAP is placed in a shift-DR state, the bypass register is placed between TDI and TDO. The advantage of the BYPASS instruction is that it shortens the boundary scan path when multiple devices are connected together on a board.

## **PRIVATE**

Do not use these instructions. They are reserved for future use and engineering mode.

## **EXTEST**

The EXTEST instruction drives the preloaded data out through the system output pins. This instruction also connects the boundary scan register for serial access between the TDI and TDO in the Shift-DR controller state. IEEE Standard 1149.1 mandates that the TAP controller be able to put the output bus into a tri-state mode. The boundary scan register has a special bit located at bit #109. When this scan cell, called the "EXTEST output bus tri-state," is latched into the preload register during the Update-DR state in the TAP controller, it directly controls the state of the output (Q-bus) pins, when the EXTEST is entered as the current instruction. When HIGH, it enables the output buffers to drive the output bus. When LOW, this bit places the output bus into a High Z condition. This bit can be set by entering the SAMPLE/PRELOAD or EXTEST command, and then shifting the desired bit into that cell during the Shift-DR state. During Update-DR, the value loaded into that shift-register cell latches into the preload register. When the EXTEST instruction is entered, this bit directly controls the output Q-bus pins. Note that this bit is pre-set LOW to enable the output when the device is powered up, and also when the TAP controller is in the Test-Logic-Reset state.

## **JTAG DC Operating Characteristics**

(Over the Operating Temperature Range,  $V_{DD}=1.8V\pm5\%$ )

| Parameter                  | Symbol      | Min  | Max          | Units   | Notes                       |
|----------------------------|-------------|------|--------------|---------|-----------------------------|
| JTAG Input High Voltage    | $V_{IH1}$   | 1.3  | $V_{DD}+0.3$ | V       |                             |
| JTAG Input Low Voltage     | $V_{IL1}$   | -0.3 | 0.5          | V       |                             |
| JTAG Output High Voltage   | $V_{OH1}$   | 1.4  | -            | V       | $ I_{OH1} =2mA$             |
| JTAG Output Low Voltage    | $V_{OL1}$   | -    | 0.4          | V       | $I_{OL1}=2mA$               |
| JTAG Output High Voltage   | $V_{OH2}$   | 1.6  | -            | V       | $ I_{OH2} =100uA$           |
| JTAG Output Low Voltage    | $V_{OL2}$   | -    | 0.2          | V       | $I_{OL2}=100uA$             |
| JTAG Input Leakage Current | $I_{LJTAG}$ | -100 | +100         | $\mu A$ | $0 \leq V_{in} \leq V_{DD}$ |



**IS61DDB41M18A**  
**IS61DDB451236A**



|                             |              |    |    |         |                           |
|-----------------------------|--------------|----|----|---------|---------------------------|
| JTAG Output Leakage Current | $I_{LOJTAG}$ | -5 | +5 | $\mu A$ | $0 \leq V_{out} \leq VDD$ |
|-----------------------------|--------------|----|----|---------|---------------------------|

Notes:

1. All voltages referenced to VSS (GND); All JTAG inputs and outputs are LVTTTL-compatible.

### JTAG AC Test Conditions

(Over the Operating Temperature Range,  $V_{DD}=1.8V\pm5\%$ ,  $V_{DDO}=1.5V/1.8V$ )

| Parameter                               | Symbol    | Conditions | Units |
|-----------------------------------------|-----------|------------|-------|
| Input Pulse High Level                  | $V_{IH1}$ | 1.3        | V     |
| Input Pulse Low Level                   | $V_{IL1}$ | 0.5        | V     |
| Input Rise Time                         | $T_{R1}$  | 1.0        | ns    |
| Input Fall Time                         | $T_{F1}$  | 1.0        | ns    |
| Input and Output Timing Reference Level |           | 0.9        | V     |

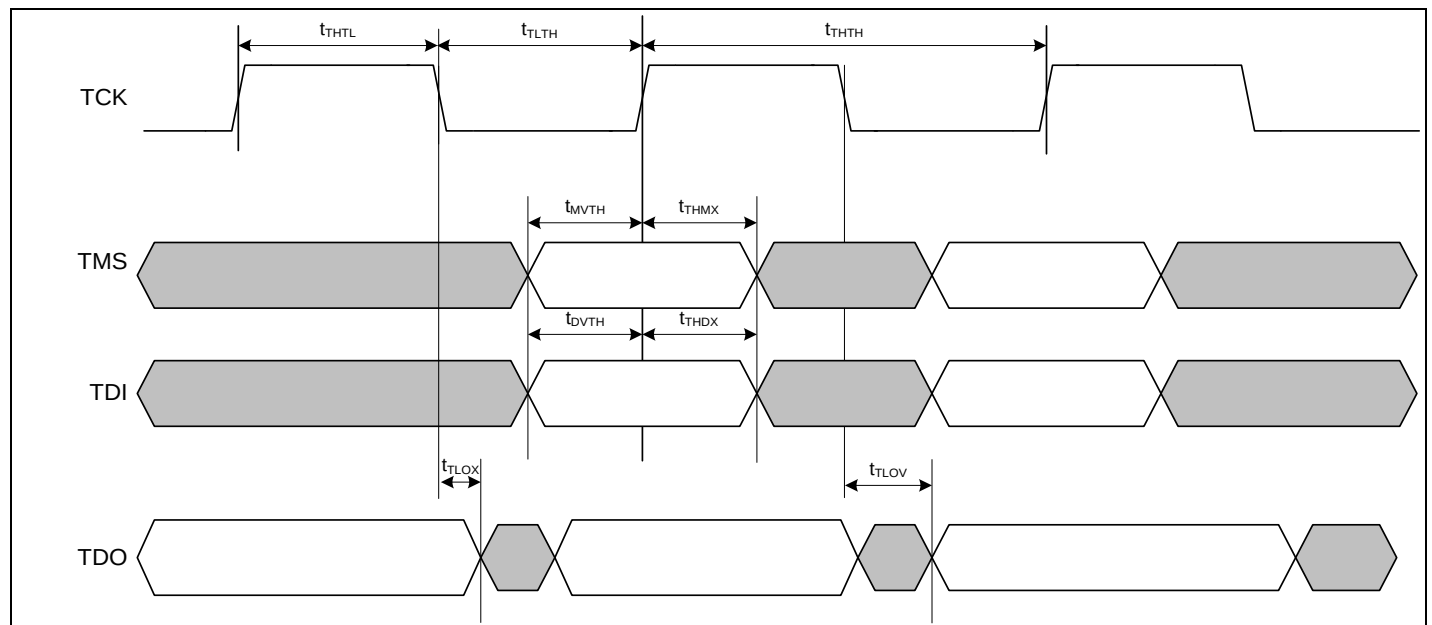
### JTAG AC Characteristics

(Over the Operating Temperature Range,  $V_{DD}=1.8V\pm5\%$ ,  $V_{DDO}=1.5V/1.8V$ )

| Parameter                | Symbol     | Min | Max | Units |
|--------------------------|------------|-----|-----|-------|
| TCK cycle time           | $t_{THTH}$ | 50  | —   | ns    |
| TCK high pulse width     | $t_{HTHL}$ | 20  | —   | ns    |
| TCK low pulse width      | $t_{LTHT}$ | 20  | —   | ns    |
| TMS Setup                | $t_{MVTH}$ | 5   | —   | ns    |
| TMS Hold                 | $t_{THMX}$ | 5   | —   | ns    |
| TDI Setup                | $t_{DVTH}$ | 5   | —   | ns    |
| TDI Hold                 | $t_{THDX}$ | 5   | —   | ns    |
| Capture Setup            | $t_{CVTH}$ | 5   | —   | ns    |
| Capture Hold             | $t_{THCX}$ | 5   | —   | ns    |
| TCK Low to Valid Data*   | $t_{TLOV}$ | —   | 10  | ns    |
| TCK Low to Invalid Data* | $t_{TLQX}$ | 0   | —   | ns    |

Note: See AC Test Loading(c)

### JTAG Timing Diagram



#### Instruction Set

| Code | Instruction      | TDO Output                     |
|------|------------------|--------------------------------|
| 000  | EXTEST           | Boundary Scan Register         |
| 001  | IDCODE           | 32-bit Identification Register |
| 010  | SAMPLE-Z         | Boundary Scan Register         |
| 011  | PRIVATE          | Do Not Use                     |
| 100  | SAMPLE(/PRELOAD) | Boundary Scan Register         |
| 101  | PRIVATE          | Do Not Use                     |
| 110  | PRIVATE          | Do Not Use                     |
| 111  | BYPASS           | Bypass Register                |

#### ID Register Definition

| Revision Number (31:29) | Part Configuration (28:12) | Vendor ID Code (11:1) | Start Bit (0) |
|-------------------------|----------------------------|-----------------------|---------------|
| 000                     | 0TDEF0WX01PQLBTS0          | 00011010101           | 1             |

#### Part Configuration Definition:

1. DEF = 001 for 18Mb, 010 for 36Mb, 011 for 72Mb
2. WX = 11 for x36, 10 for x18
3. P = 1 for II+(QUAD-P/DDR-IIP), 0 for II(QUAD/DDR-II)
4. Q = 1 for QUAD, 0 for DDR-II
5. L = 1 for RL=2.5, 0 for RL≠2.5
6. B = 1 for burst of 4, 0 for burst of 2
7. S = 1 for Separate I/O, 0 for Common I/O
8. T = 1 for ODT option, 0 for No ODT option

# Boundary Scan Exit Order

| ORDER | Pin ID |
|-------|--------|
| 1     | 6R     |
| 2     | 6P     |
| 3     | 6N     |
| 4     | 7P     |
| 5     | 7N     |
| 6     | 7R     |
| 7     | 8R     |
| 8     | 8P     |
| 9     | 9R     |
| 10    | 11P    |
| 11    | 10P    |
| 12    | 10N    |
| 13    | 9P     |
| 14    | 10M    |
| 15    | 11N    |
| 16    | 9M     |
| 17    | 9N     |
| 18    | 11L    |
| 19    | 11M    |
| 20    | 9L     |
| 21    | 10L    |
| 22    | 11K    |
| 23    | 10K    |
| 24    | 9J     |
| 25    | 9K     |
| 26    | 10J    |
| 27    | 11J    |
| 28    | 11H    |
| 29    | 10G    |
| 30    | 9G     |
| 31    | 11F    |
| 32    | 11G    |
| 33    | 9F     |
| 34    | 10F    |
| 35    | 11E    |
| 36    | 10E    |

| ORDER | Pin ID |
|-------|--------|
| 37    | 10D    |
| 38    | 9E     |
| 39    | 10C    |
| 40    | 11D    |
| 41    | 9C     |
| 42    | 9D     |
| 43    | 11B    |
| 44    | 11C    |
| 45    | 9B     |
| 46    | 10B    |
| 47    | 11A    |
| 48    | 10A    |
| 49    | 9A     |
| 50    | 8B     |
| 51    | 7C     |
| 52    | 6C     |
| 53    | 8A     |
| 54    | 7A     |
| 55    | 7B     |
| 56    | 6B     |
| 57    | 6A     |
| 58    | 5B     |
| 59    | 5A     |
| 60    | 4A     |
| 61    | 5C     |
| 62    | 4B     |
| 63    | 3A     |
| 64    | 2A     |
| 65    | 1A     |
| 66    | 2B     |
| 67    | 3B     |
| 68    | 1C     |
| 69    | 1B     |
| 70    | 3D     |
| 71    | 3C     |
| 72    | 1D     |

| ORDER | Pin ID   |
|-------|----------|
| 73    | 2C       |
| 74    | 3E       |
| 75    | 2D       |
| 76    | 2E       |
| 77    | 1E       |
| 78    | 2F       |
| 79    | 3F       |
| 80    | 1G       |
| 81    | 1F       |
| 82    | 3G       |
| 83    | 2G       |
| 84    | 1H       |
| 85    | 1J       |
| 86    | 2J       |
| 87    | 3K       |
| 88    | 3J       |
| 89    | 2K       |
| 90    | 1K       |
| 91    | 2L       |
| 92    | 3L       |
| 93    | 1M       |
| 94    | 1L       |
| 95    | 3N       |
| 96    | 3M       |
| 97    | 1N       |
| 98    | 2M       |
| 99    | 3P       |
| 100   | 2N       |
| 101   | 2P       |
| 102   | 1P       |
| 103   | 3R       |
| 104   | 4R       |
| 105   | 4P       |
| 106   | 5P       |
| 107   | 5N       |
| 108   | 5R       |
| 109   | Internal |

## Notes:

1. NC pins as defined on the **FBGA Ball Assignments** are read as "don't cares".
2. State of internal pin (#109) is loaded via JTAG

## Ordering Information

### Commercial Range: 0°C to +70°C

| Speed   | Order Part No.        | Organization | Package                        |
|---------|-----------------------|--------------|--------------------------------|
| 333 MHz | IS61DDB451236A-333M3  | 512Kx36      | 165 FBGA (15x17 mm)            |
|         | IS61DDB451236A-333M3L | 512Kx36      | 165 FBGA (15x17 mm), lead free |
|         | IS61DDB41M18A-333M3   | 1Mx18        | 165 FBGA (15x17 mm)            |
|         | IS61DDB41M18A-333M3L  | 1Mx18        | 166 FBGA (15x17 mm), lead free |
| 300 MHz | IS61DDB451236A-300M3  | 512Kx36      | 165 FBGA (15x17 mm)            |
|         | IS61DDB451236A-300M3L | 512Kx36      | 165 FBGA (15x17 mm), lead free |
|         | IS61DDB41M18A-300M3   | 1Mx18        | 165 FBGA (15x17 mm)            |
|         | IS61DDB41M18A-300M3L  | 1Mx18        | 165 FBGA (15x17 mm), lead free |
| 250 MHz | IS61DDB451236A-250M3  | 512Kx36      | 165 FBGA (15x17 mm)            |
|         | IS61DDB451236A-250M3L | 512Kx36      | 165 FBGA (15x17 mm), lead free |
|         | IS61DDB41M18A-250M3   | 1Mx18        | 165 FBGA (15x17 mm)            |
|         | IS61DDB41M18A-250M3L  | 1Mx18        | 165 FBGA (15x17 mm), lead free |

### Commercial Range: 0°C to +70°C

| Speed   | Order Part No.        | Organization | Package                        |
|---------|-----------------------|--------------|--------------------------------|
| 333 MHz | IS61DDB451236A-333B4  | 512Kx36      | 165 FBGA (13x15 mm)            |
|         | IS61DDB451236A-333B4L | 512Kx36      | 165 FBGA (13x15 mm), lead free |
|         | IS61DDB41M18A-333B4   | 1Mx18        | 165 FBGA (13x15 mm)            |
|         | IS61DDB41M18A-333B4L  | 1Mx18        | 166 FBGA (13x15 mm), lead free |
| 300 MHz | IS61DDB451236A-300B4  | 512Kx36      | 165 FBGA (13x15 mm)            |
|         | IS61DDB451236A-300B4L | 512Kx36      | 165 FBGA (13x15 mm), lead free |
|         | IS61DDB41M18A-300B4   | 1Mx18        | 165 FBGA (13x15 mm)            |
|         | IS61DDB41M18A-300B4L  | 1Mx18        | 165 FBGA (13x15 mm), lead free |
| 250 MHz | IS61DDB451236A-250B4  | 512Kx36      | 165 FBGA (13x15 mm)            |
|         | IS61DDB451236A-250B4L | 512Kx36      | 165 FBGA (13x15 mm), lead free |
|         | IS61DDB41M18A-250B4   | 1Mx18        | 165 FBGA (13x15 mm)            |
|         | IS61DDB41M18A-250B4L  | 1Mx18        | 165 FBGA (13x15 mm), lead free |

# IS61DDB41M18A IS61DDB451236A



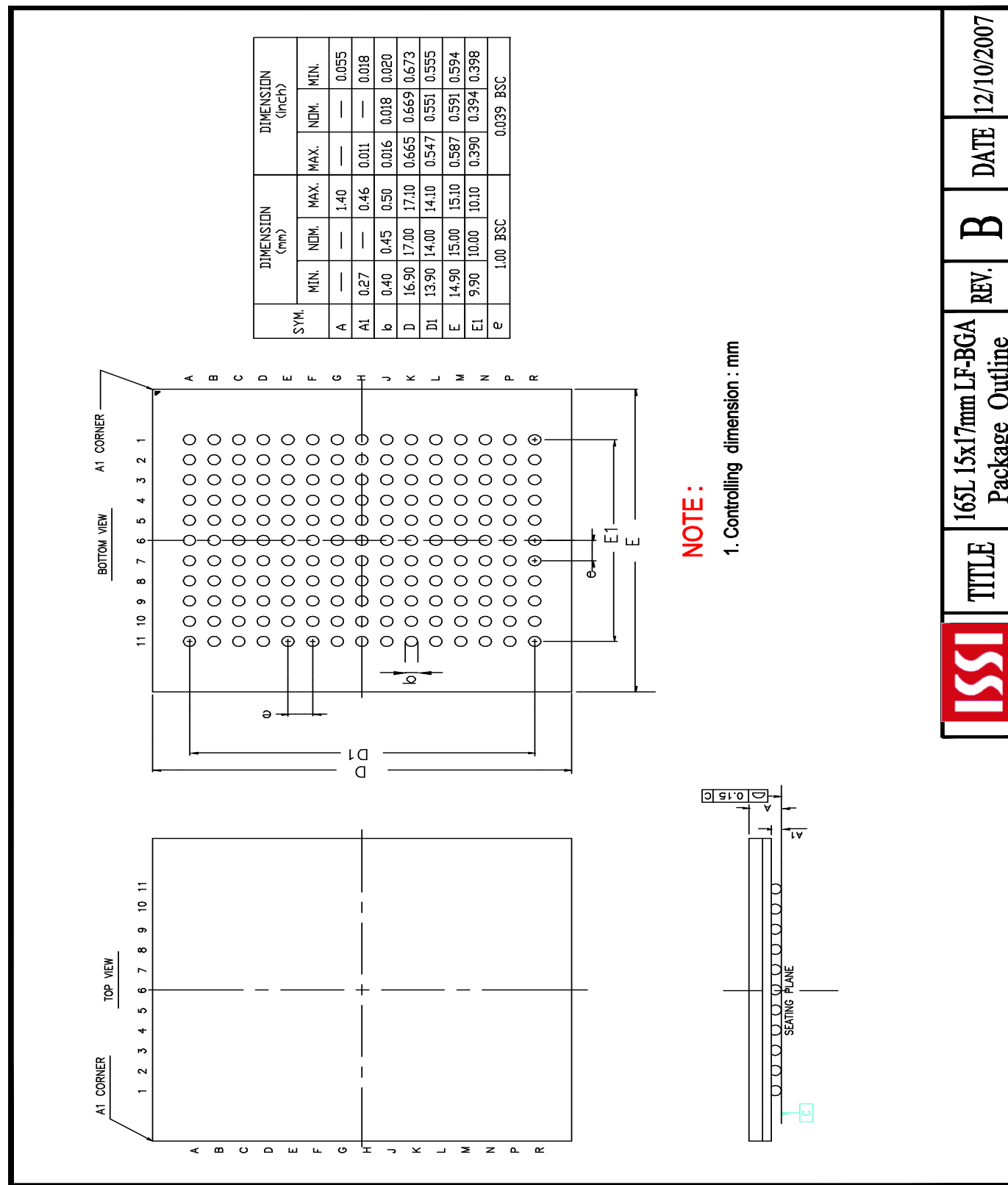
**Industrial Range: -40°C to +85°C**

| Speed   | Order Part No.         | Organization | Package                        |
|---------|------------------------|--------------|--------------------------------|
| 333 MHz | IS61DDB451236A-333M3I  | 512Kx36      | 165 FBGA (15x17 mm)            |
|         | IS61DDB451236A-333M3LI | 512Kx36      | 165 FBGA (15x17 mm), lead free |
|         | IS61DDB41M18A-333M3I   | 1Mx18        | 165 FBGA (15x17 mm)            |
|         | IS61DDB41M18A-333M3LI  | 1Mx18        | 165 FBGA (15x17 mm), lead free |
| 300 MHz | IS61DDB451236A-300M3I  | 512Kx36      | 165 FBGA (15x17 mm)            |
|         | IS61DDB451236A-300M3LI | 512Kx36      | 165 FBGA (15x17 mm), lead free |
|         | IS61DDB41M18A-300M3I   | 1Mx18        | 165 FBGA (15x17 mm)            |
|         | IS61DDB41M18A-300M3LI  | 1Mx18        | 165 FBGA (15x17 mm), lead free |
| 250 MHz | IS61DDB451236A-250M3I  | 512Kx36      | 165 FBGA (15x17 mm)            |
|         | IS61DDB451236A-250M3LI | 512Kx36      | 165 FBGA (15x17 mm), lead free |
|         | IS61DDB41M18A-250M3I   | 1Mx18        | 165 FBGA (15x17 mm)            |
|         | IS61DDB41M18A-250M3LI  | 1Mx18        | 165 FBGA (15x17 mm), lead free |

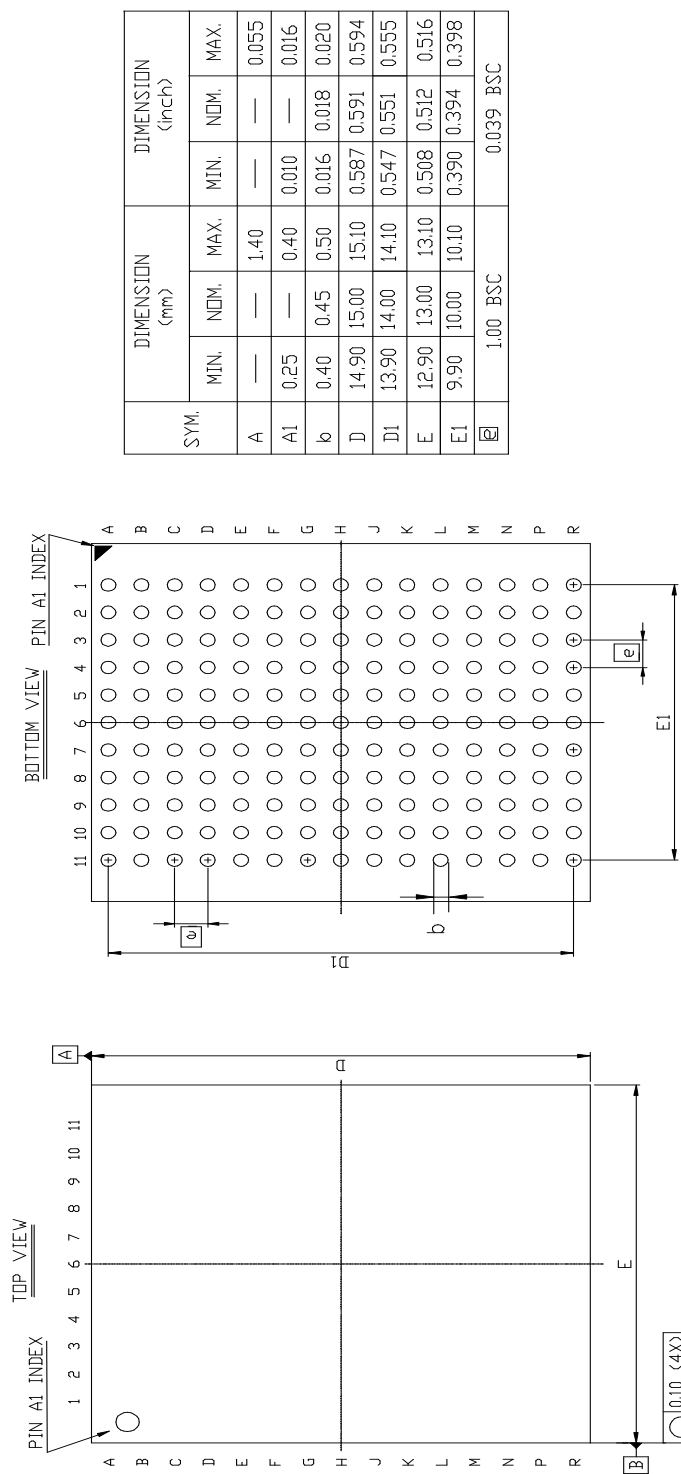
**Industrial Range: -40°C to +85°C**

| Speed   | Order Part No.         | Organization | Package                        |
|---------|------------------------|--------------|--------------------------------|
| 333 MHz | IS61DDB451236A-333B4I  | 512Kx36      | 165 FBGA (13x15 mm)            |
|         | IS61DDB451236A-333B4LI | 512Kx36      | 165 FBGA (13x15 mm), lead free |
|         | IS61DDB41M18A-333B4I   | 1Mx18        | 165 FBGA (13x15 mm)            |
|         | IS61DDB41M18A-333B4LI  | 1Mx18        | 165 FBGA (13x15 mm), lead free |
| 300 MHz | IS61DDB451236A-300B4I  | 512Kx36      | 165 FBGA (13x15 mm)            |
|         | IS61DDB451236A-300B4LI | 512Kx36      | 165 FBGA (13x15 mm), lead free |
|         | IS61DDB41M18A-300B4I   | 1Mx18        | 165 FBGA (13x15 mm)            |
|         | IS61DDB41M18A-300B4LI  | 1Mx18        | 165 FBGA (13x15 mm), lead free |
| 250 MHz | IS61DDB451236A-250B4I  | 512Kx36      | 165 FBGA (13x15 mm)            |
|         | IS61DDB451236A-250B4LI | 512Kx36      | 165 FBGA (13x15 mm), lead free |
|         | IS61DDB41M18A-250B4I   | 1Mx18        | 165 FBGA (13x15 mm)            |
|         | IS61DDB41M18A-250B4LI  | 1Mx18        | 165 FBGA (13x15 mm), lead free |

Package drawing – 15x17x1.4 BGA



Package drawing – 13x15x1.4 BGA



| SYM. | DIMENSION (mm) |       |       | DIMENSION (inch) |       |       |
|------|----------------|-------|-------|------------------|-------|-------|
|      | MIN.           | NOM.  | MAX.  | MIN.             | NOM.  | MAX.  |
| A    | —              | —     | 1.40  | —                | —     | 0.055 |
| A1   | 0.25           | —     | 0.40  | 0.010            | —     | 0.016 |
| b    | 0.40           | 0.45  | 0.50  | 0.016            | 0.018 | 0.020 |
| D    | 14.90          | 15.00 | 15.10 | 0.587            | 0.591 | 0.594 |
| D1   | 13.90          | 14.00 | 14.10 | 0.547            | 0.551 | 0.555 |
| E    | 12.90          | 13.00 | 13.10 | 0.508            | 0.512 | 0.516 |
| E1   | 9.90           | 10.00 | 10.10 | 0.390            | 0.394 | 0.398 |
| ⌀    | 1.00 BSC       |       |       | 0.039 BSC        |       |       |

**NOTE :**

1. CONTROLLING DIMENSION : MM .

|             |              |                                           |             |          |             |            |
|-------------|--------------|-------------------------------------------|-------------|----------|-------------|------------|
| <b>ISSI</b> | <b>TITLE</b> | 165L 13x15x1.4mm LFBGA<br>Package Outline | <b>REV.</b> | <b>A</b> | <b>DATE</b> | 11/29/2011 |
|-------------|--------------|-------------------------------------------|-------------|----------|-------------|------------|



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В нашем ассортименте представлены ведущие мировые производители активных и пассивных электронных компонентов.

Нашей специализацией является поставка электронной компонентной базы двойного назначения, продукции таких производителей как XILINX, Intel (ex.ALTERA), Vicor, Microchip, Texas Instruments, Analog Devices, Mini-Circuits, Amphenol, Glenair.

Сотрудничество с глобальными дистрибьюторами электронных компонентов, предоставляет возможность заказывать и получать с международных складов практически любой перечень компонентов в оптимальные для Вас сроки.

На всех этапах разработки и производства наши партнеры могут получить квалифицированную поддержку опытных инженеров.

Система менеджмента качества компании отвечает требованиям в соответствии с ГОСТ Р ИСО 9001, ГОСТ РВ 0015-002 и ЭС РД 009

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